MASTER'S THESIS

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Development of an OpenOCD compatible Debugger for ARM - CMARMJTAG

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Declaration

"I confirm that this thesis is entirely my own work. All sources and quotations have been fully acknowledged in the appropriate places with adequate footnotes and citations. Quotations have been properly acknowledged and marked with appropriate punctuation. The works consulted are listed in the bibliography. This paper has not been submitted to another examination panel in the same or a similar form, and has not been published. "

Vienna, 15.06.2011

Place, Date

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Kurzfassung

Im Rahmen dieser Arbeit wurde die Soft-/Firmwareentwicklung eines µC (Mikrocontroller) basierenden Debuggers beschrieben, die Funktionalität des entwickelten Debuggers ausführlich getestet und verglichen mit kommerziell verfügbaren Debugger. Der, für den Debugger, verwendete µC ist eine LPC1768 von NXP¹ und basiert auf den ARM² Cortex-M3 Core. In dieser Arbeit wurden die grundlegenden Funktionalitäten des Cores erklärt. Es wurden ausschließlich open-source und freie Entwicklungswerkzeuge verwendet. Als Kommunikationsinterface zwischen dem Host und dem Debugger wurde USB³ (Universal Serial Bus) verwendet und zwischen dem Debugger und der TEP (Target Embedded Platform) wurde JTAG (Joint Test Action Group) verwendet. In dieser Arbeit wird, durch die Komplexität der verwendeten Interfaces, nur auf ausgewählte, projektrelevante Kapitel eingegangen. OpenOCD⁴ (Open On-Chip Debugger) wurde verwendet, um mit dem Debugger über USB zu kommunizieren. Der dafür notwendige Interfacedriver wurde implementiert und ausführlich dokumentiert. Die Firmware, welche die Funktionalität des Debuggers implementiert, und sowohl für die Kommunikation zum Host als auch zum TEP zuständig ist, wurde implementiert und ausführlich dokumentiert. Verschiedene Performance Tests wurden durchgeführt, um den entwickelten Debugger mit kommerziell verfügbaren Debugger zu vergleichen. Zum Leistungsvergleich wurde ein FTDI⁵-basierender Debugger der Firma Amontec⁶ namens Amontec JTAGKey Tiny herangezogen.

Schlagwörter: Debugger, Cortex-M3, USB, JTAG, FTDI-Chip

- ³ http://www.usb.org/home
- ⁴ http://openocd.berlios.de/web/
- ⁵ http://www.ftdichip.com/
- ⁶ http://www.amontec.com/

¹ http://www.nxp.com/

² http://www.arm.com/

Abstract

This thesis describes the Soft-/Firmware development of a µC-based debugger. The functionality of the debugger is tested and compared to commercial available debugger. The used µC is a LPC1768 from NXP and is based on the ARM Cortex-M3 core. This thesis highlights the fundamentals of the CM3 (Cortex-M3) core. In this project open-source and free available development tools were used. The communication interface between the host and the debugger is based on USB. To be able to communicate with the TEP, JTAG was used. Due to the complexity of the interfaces, only selected topics of the utilized interfaces were explained. OpenOCD was used to interact with debugger based on USB. OpenOCD can be used to transfer pre-compiled code to the TEP, to control the code execution and to examine the TEP state. To be able to communicate with the debugger an interface driver was developed. The configuration of this driver and its functionality is explained in this thesis. The firmware, running on the debugger, was implemented and is documented in this thesis. Various performance tests were executed to be able to validate the functionality of the debugger. The results of these tests are documented and compared to a commercial available debugger provided by Amontec. The Amontec JTAGKey is a FTDI-based debugger and is applied in many development processes.

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1 Introduction

This thesis focuses on the development of a JTAG Debugger, which can be used to debug state-of-the-art microcontrollers. These microcontrollers have to have a JTAG interface which gives the debugger the ability to communicate with the debug module of the microcontroller.

Many debuggers are available with different features and abilities. Currently the Technikum Wien⁷ uses different microcontrollers in their courses dedicated to embedded system engineering. Some of the μ Cs (microcontrollers) have a debugger on-board and some of them are programmed via external debuggers.

The on-board debuggers are often realized with an FTDI Chip⁸ which implements the gateway between the USB interface and the JTAG interface. This device can not only be used for this purpose. It can also be used to redirect the hardware RS232 interface of the μ C to the USB interface. The FTDI chip has the advantage that this device is especially designed for debugging and programming purposes of various microcontrollers.

The disadvantage is that the FTDI chip is very expensive. It costs \in 8.90 per unit. To get a working debugger based on the FTDI chip it is necessary to use an external EEPROM, which costs \in 0.30, and some passive components. This means that a debugger costs about \in 10.00 and it can only be used as a debugger.

The external debugger is the J-Link from Segger⁹ and the ULINK2 from ARM/Keil¹⁰. The problem is that a limited amount of external debuggers are available on the Technikum Wien and e.g. the J-Link costs \in 248.00 and the ULINK costs \in 289.00.

To gain sustainable knowledge the students of the Technikum Wien should be able to use the applied embedded system while they attend a course dedicated to embedded system engineering. This means that the development environment, the embedded board, and the debugger should be able to be used at home, easy to maintain, and able to be bought by the students. An inquiry with the students has shown that the students are be poised to pay between \in 50.00 till \in 60.00 for such a development equipment.

The mentioned equipment will cost \in ~400.00 if an external debugger is delivered within the package and cost \in ~160.00 if the on-board or a debugger based on the FTDI chip is used.

One of the first steps to lowering the costs of the development equipment can be to replace the debugger by a microcontroller which "simulates" a debugger.

⁷ http://www.technikum-wien.at/

⁸ http://www.ftdichip.com/

⁹ http://www.segger.com/cms/

¹⁰ http://www.keil.com/

The usage of a microcontroller used as debugger has the advantage that it is cheaper than the currently used debuggers and the microcontroller can be used for basic tasks in undergraduate courses dedicated to embedded system engineering.

E.g. a Cortex-M3 microcontroller with a minimum of internal memory costs \in 3.44. Additionally some passive external components are required which means that the debugger costs less than the FTDI chip itself. These arguments are the baseline for this thesis.

2 Project-Specification

After the introduction it is necessary to specify the features and abilities of the debugger and which functionalities are not supported. To be able to specify the features and abilities it is necessary to analyse the project configuration.

Figure 1 gives an overview over the basic project configuration. The Host illustrates the workstation where the development tools for the Target μ C are installed. The interface between the Host and the CMARMJTAG is USB. This interface will be explained in chapter 4. The CMARMJTAG is a state-of-the-art microcontroller which is the gateway between the USB and JTAG interface. The JTAG interface is required to transfer the debug information from the CMARMJTAG to the Target μ C. The JTAG* interface is not the standard JTAG interface of the CMARMJTAG. This interface is necessary to simulate a JTAG interface. In this thesis three possible methods to simulate a JTAG interface are explained.

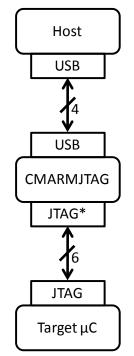


Figure 1: Basic project configuration

The JTAG Debugger should have the name CMARMJTAG. This name is composed of three phrases.

- CM \rightarrow Cortex-M
- ARM → ARM Architecture
- JTAG \rightarrow Interface which is used for the debug communication

The applied microcontroller for this project is an ARM Cortex-M3 from NXP called LPC1768. The used architecture (ARM) and the type of the microcontroller (Cortex-M) can

be found in the abbreviation of the JTAG Debugger. Also the interface which is used between the CMARMJTAG and the target μ C (JTAG) can be found in the abbreviation. The JTAG Debugger should:

- be able to integrate into OpenOCD (Open On-Chip-Debugger); OpenOCD is explained in chapter 5
- support ARM-JTAG interface communication
- support variable JTAG speeds
- support real-time debugging
- support in-system programming
- support boundary-scan testing
- support all microcontrollers which are supported into OpenOCD
- use a microcontroller which is:
 - o available
 - o low-cost
 - o and a state-of-the-art microcontroller

For this project the following features are no design goals:

- displaying and storing of Embedded Trace information
- Power Debugging founded by IAR Systems
- a USB/Serial interface
- a SWD interface communication

3 Examples of µC-based debugger

There are projects which are dealing with the development of μ C-based debugger. This chapter gives an overview of the related projects.

The SEGGER J-Link [cmp. to p. 24, SEGUM] is a USB powered JTAG emulator which supports a large number of ARM cores. J-Link is based on a 32-bit RISC CPU and is used for development and production purposes. It connects via USB to a PC running Microsoft Windows 2000 or later. J-Link has a built-in 20-pin JTAG connector, which is compatible with the standard 20-pin connector defined by ARM.

The RLink from Raisonance¹¹ [cmp. to p. 3, RLINK09] is a microcontroller debugger and programmer which supports a range of target interfaces (JTAG, SWD, SWIM, ICC) and connects to 32-bit and 8-bit μ Cs to program the target device and debug application in real-time. The standard RLink consists of a ST7365xARxT1 μ C. This chip is based on an ARM7 core and used in the STM32 Primer1/2 of Raisonance. On the STM Primer1, JTAG is used to program and debug the STM32 and on STM32 Primer2 SWD (Serial Wire Debug) is used.

USBprog¹² [cmp. to USBJTAG07] is a free programming adapter. The adapter is based on an ATmega32 and can be used for programming and debugging AVR and ARM cores, as USB to RS232 converter, as JTAG interface or as simple I/O interface. The adapter allows real-time debugging, setting breakpoints and single stepping.

eStick-JTAG¹³ [cmp. to ESJTAG08] is a USB to JTAG adapter to program ARM-based microcontrollers. This adapter allows real-time debugging, in-system programming and boundary-scan testing for embedded targets. This adapter is based on the AT91USB162 of Atmel and was developed at the UAS Technikum Wien.

Table 1 lists μ C-based debuggers and FTDI-based debuggers, the prices of them, the theoretical download speed and whether they are supported by OpenOCD or not.

Name	Price[€]	Download speed	OpenOCD-Support
Segger J-Link*	248.00	12 Mibit/s	Yes
USBJTAG*	44.00	960 kibit/s	Yes
USBprog*	34.00	4,8 kibit/s	Yes
JTAGKey-Tiny**	29.00	6 Mibit/s	Yes
eStick JTAG*	15.00	70,4 kibit/s	Yes

Table 1: JTAG Debugger

¹¹ http://www.raisonance.com/

¹² http://www.embedded-projects.net/index.php?page_id=135

¹³ http://code.google.com/p/estick-jtag/

^{*} µC-based debugger

^{**} FTDI-based debugger

USBJTAG is a Windows based EJTAG tool for all MIPS core CPUs. It is possible to read and write the memory and program the flash of these CPUs. The USBJTAG is supported by OpenOCD. [cmp. to EJTAG11]

The Segger J-Link is the fastest debugger and offers many features and is supported in OpenOCD. The USBprog is cheaper than the USBJTAG but does not achieve the download rate. It is also supported by OpenOCD. The JTAGKey Tiny provided by Amontec is the most efficient debugger. This debugger is based on the FTDI-Chip and is much faster than the mentioned μ C-based debugger at approximately the same price. The eStick-JTAG as already explained is a very low-cost μ C-based debugger and achieves a considerable download speed. This debugger is not supported by OpenOCD by default. It is possible to patch OpenOCD with an available patch file to integrate this debugger into OpenOCD. The CMARMJTAG should gain the download speed of the JTAGKey Tiny but with some modifications. After the reset the ARM CPU operates at a core frequency of 4 MHz provided by the internal oscillator. If the CPU runs with the internal oscillator the maximum achievable JTAG clock is 2 MHz. The theoretical download speed mentioned in table 1 is not possible at this configuration.

4 Selected Topics of the utilized interfaces

After the analyses of the state-of-the-art debuggers it is necessary to focus on the most important interfaces which are used in this thesis. This chapter focuses on the utilized interfaces. On the one hand the USB interface is required to connect the CMARMJTAG to the Host and on the other hand JTAG is required to transfer data between the target microcontroller and the CMARMJTAG.

USB in a nutshell

USB is a handy solution if a computer is used to communicate with a device outside of a computer. The interface is suitable for mass-produced, standard peripheral types as well as small-volume designs, including one-of-a-kind projects. Additionally many microcontrollers based on ARM provide a USB controller. USB offers some benefits for both the users and the developers.

Benefits for Users:

- Ease of Use
- Automatic configuration
 - The appropriate software driver is loaded automatically. Otherwise the OS asks for the driver and automatically installs it.
- Easy to connect
 - Typical computers have USB ports built in where the external device can be connected easily.
- Easy cables
 - USB connectors are small and compact in contrast to typical RS-232 and parallel connectors.
- Hot pluggable
 - The USB device can be connected at any time without damaging the host system
- No power-supply required (sometimes)

Benefits for Developers

- Versatility
 - USB's four transfer types and three speeds make the interface feasible for many types of peripherals.
- Operating System Support
 - The OS (Operating System) automatically detects if a device is attached and removed from a system
 - The OS is able to communicate with newly attached devices to find out how to exchange data with them.
 - The OS provides a mechanism that enables software drivers to communicate with the computer's USB hardware and the applications that want to access USB peripherals
- Peripheral support
 - Every USB peripheral must have a (may be built-in) controller chip that manages the details of USB communications. Some of them are complete microcontrollers or the USB controller is connected externally.

[cmp. p. 2-9, USBC]

IEEE Std. 1149.1 in a nutshell

The test logic, the Test Access Port (TAP) and the signals of JTAG are explained in chapter 4.2. The IEEE¹⁴ Std. 1149.1 standard defines test logic that can be an integrated circuit to provide standardized approaches to test the interconnect between integrated circuits once they have been assembled onto a printed circuit board or other substrate, to test the integrated circuit itself, and to observe or modify circuit activity during the component's normal operation.

The test logic consists of a boundary-scan register and other building blocks and is accessed through a Test Access Port (TAP). [cmp. to p1, IEEE1149.1]

4.1 USB-Universal Serial Bus

As explained the CMARMJTAG uses two interfaces which are necessary to communicate on the one hand with OpenOCD and on the other hand with the target hardware. One of the interfaces is USB which is used to connect to OpenOCD. OpenOCD is used to emulate the states & functionalities of the debug module of the target hardware on the host machine. This software is described later. This chapter focuses on the descriptor types and does not explain basic transactions and functionalities of the USB interface.

To be able to communicate via USB with the host machine it is necessary to configure the USB-Device. Therefore a device descriptor data structure is used. All USB devices

¹⁴ http://www.ieee.org/index.html

respond to requests for the standard USB descriptors. The device must store the information in the descriptors and respond to requests for the descriptors. To be able to understand how the CMARMJTAG is configured and is registered on the host machine it is necessary to explain the required types of descriptors and the configuration possibilities. USB-Descriptors:

- Device Descriptor
- Configuration Descriptor
- Interface Descriptor
- Endpoint Descriptor
- String Descriptor

The descriptors types which are used in the main-file of the firmware are described in detail.

Device Descriptor

The device descriptor contains basic information about the device. The host first reads the device descriptor when the device is attached. This descriptor provides information which the host needs to retrieve additional information from the device. The device descriptor has 14 fields. Table 1 lists the fields in the order they occur in the descriptor. The descriptor includes information about the descriptor, the device, its configuration and any classes the device belongs to. [cmp. to p.96, USBC]

Offset	Field	Size	Description
(dec)		(bytes)	
0	bLength	1	Descriptor size in bytes
1	bDescriptorType	1	The constant device
2	bcdUSB	2	USB Specification release number
4	bDeviceClass	1	Class code
5	bDeviceSubClass	1	Subclass code
6	bDeviceProtocol	1	Protocol code
7	bMaxPacketSize0	1	Max. packet size for endpoints
8	idVendor	2	Vendor ID
10	idProduct	2	Product ID
12	bcdDevice	2	Device release number
14	iManufacturer	1	Index of string descriptor for the manufacturer
15	iProduct	1	Index of string descriptor for the manufacturer
16	iSerialNumber	1	Index of string descriptor containing the serNum
17	bNumConfiguration	1	Number of possible configurations

Table 2: Device Descriptor [p.97, USBC]

The following descriptions group the information by function. Descriptor:

- **bLength**: The length in bytes of the descriptor
- **bDescriptorType**: The device descriptor type constant

Device:

- bcdUSB: The USB specification that the device and its descriptors comply with in BCD (binary-coded decimal) format.
- **idVendor**: Vendor ID which could be used from the device driver to identify the device.
- **idProduct**: The product ID identifies the device. Each product ID is specific to a vendor ID, so multiple vendors can use the same product ID without conflict.
- **iManufacturer**: An index that points to a string describing the manufacturer. This value is zero if there is no manufacturer.
- **iProduct**: An index that points to a string describing the product. This value is zero if there is no string descriptor.
- **iSerialNumber**: An index that points to a string containing the device's serial number. This value is zero if there is no serial number. Some device classes (such as mass storage) require serial numbers. Serial numbers are useful if users may have more than one identical device on the bus and the host needs to keep track of which is which even after rebooting.

Configuration:

- **bNumConfiguration**: The number of configurations the device supports.
- **bMaxPacketSize0**: The maximum packet size for the standard endpoints. The host uses this information in the requests that follow.
- **bDeviceClass**: For devices whose function is defined at the device level, this field specifies the device's class. Values from 0x01 to 0xFE are reserved for USB's defined classes. The value 0x00 means that the interface descriptor names the class.
- **bDeviceSubclass**: This field can specify a subclass within a class. If bDeviceClass is 0, the bDeviceSubClass must be 0.
- **bDeviceProtocol**: This field can specify a protocol defined by the selected class or subclass.

[cmp. p. 96-101, USBC]

Configuration Descriptor

When the device descriptor, which is explained in the previous chapter, is retrieved, the host can load the device configuration, the parameters for the interface, and the endpoint descriptors. Each device has at least one configuration that specifies the device's features and the abilities. For the CMARMJTAG one configuration is enough, but the declaration of multiple configurations for one device is also possible. Only one configuration is active at a time and every configuration requires a descriptor. The configuration descriptor contains information about the device's use of power and the number of interfaces supported. Each configuration descriptor has subordinate descriptors, including one or more interface descriptors and optional endpoint descriptors.

The configuration descriptor has eight fields. Table 2 lists the fields in the order they occur in the descriptor. The descriptor includes information about the descriptor, the device, its configuration and the device's use of power in that configuration. [cmp. to p. 101, USBC]

Offset	Field	Size	Description
(dec)		(bytes)	
0	bLength	1	Descriptor size in bytes
1	bDescriptorType	1	The constant configuration
2	wTotalLength	2	The number of bytes in the configuration
			descriptor and all of its subordinate
			descriptors
4	bNumInterfaces	1	Number of interfaces in the configuration
5	bConfigurationValue	1	ID for requests
6	iConfiguration	1	Index of string descriptor for the
			configurations
7	bmAttributes	1	Self/bus power and remote wakeup settings
8	bMaxPower	1	Bus power required, expressed as (maximum
			miliamperes/2)

The following descriptions group the information by function. Descriptor:

- **bLength**: The length (in bytes) of the descriptor.
- **bDescriptorType**: The configuration descriptor type constant
- **wTotalLength**: The number of bytes in the configuration descriptor and all of its subordinate descriptors.

Configuration:

- **bConfigurationValue**: Indentifies the configuration for the requests. Must be 1 or higher. A request with a value of zero causes the device to enter the not configured state.
- **iConfiguration**: Index to a string that describes the configuration. This value is zero if there is no string descriptor.
- **bNumInterfaces**: The number of interfaces in the configuration. The minimum is 1.
- bmAttributes: Bit 0=1 if the device is self-powered or 0 if bus-powered. Bit 5=1 if the device supports the remote wakeup feature, which enables a suspended USB device to tell its host that the device wants to communicate. A USB device must enter the Suspend state if there has been no bus activity for 3 milliseconds. If an event at a suspended device requires action from the host, a device with remote wakeup enabled can request the host to resume communications. The other bits in the field are unused. Bits 0 through 4 must be 0. Bit 7 must be 1.
- bMaxPower: Specifies how much bus current a device requires. The bMaxPower value equals one half the numbers of milliamperes required. If the device requires 200 milliamperes, bMaxPower=100. The maximum current a device can request is 500 milliamperes.

[cmp. p. 101-103, USBC]

Interface Descriptor

After the configuration descriptor the interface descriptor has to be specified. The interface descriptor provides information about a function or feature that a device implements. The descriptor contains class, subclass, and protocol information and the number of endpoints the interface uses.

In the configuration descriptor the number of interfaces is specified, which means that a configuration can have multiple interfaces that are active at the same time. That is a big difference between the configuration and interface descriptor. Only one configuration descriptor can be active at a time, but multiple interfaces can be active at a time. Each interface has its own interface descriptor and subordinate descriptor. Devices that uses isochronous transfers, the transfer type is specified in the next chapter, must have alternate interfaces because the default interface must request no isochronous transfer. Changing interfaces is simpler then changing configurations.

The interface descriptor has nine fields. Table 4 lists the field in the order they occur in the descriptor. [cmp. to p.108, USBC]

Offset	Field	Size	Description
(dec)		(bytes)	
0	bLength	1	Descriptor size in bytes
1	bDescriptorType	1	The constant interface
2	bInterfaceNumber	1	Number identifying this interface
3	bAlternateSetting	1	Value used to select an alternate setting
4	bNumEndpoints	1	Number of endpoints supported, not counting
			standard endpoint
5	bInterfaceClass	1	Class code
6	bInterfaceSubclass	1	Subclass code
7	bInterfaceProtocol	1	Protocol code
8	iInterface	1	Index of string descriptor for the interface

Table 4: Interface Descriptor [p.108, USBC]

The following descriptions group the information by function. Descriptor:

- **bLength**: The number of bytes in the descriptor.
- **bDescriptorType**: The interface descriptor type constant

Interface:

- **iInterface**: Index to a string that describes the interface. This value is zero if there is no string descriptor.
- **bInterfaceNumber**: Identifies the interface. In a composite device, a configuration has multiple interfaces that are active at the same time. Each interface must have a descriptor with a unique value in this field. The default is zero.
- **bAlternateSetting**: When a configuration supports multiple, mutually exclusive interfaces, each of the interfaces has a descriptor with the same value in bInterfaceNumber and a unique value in bAlternateSetting.
- **bNumEndpoints**: The number of endpoints the interface supports in addition to the standard endpoints. For a device that supports only the standard endpoint, bNumEndpoints is zero.
- **bInterfaceClass**: Similar to bDeviceClass in the device descriptor, but for devices with a class specified by the interface. 0xFF indicates a vendor-defined class. Zero is reserved.
- **bInterfaceSubClass**: Similar to bDeviceSubClass in the device descriptor, but for devices with a class defined by the interface. For interfaces that belong to a class, this field may specify a subclass within the class.
- **bInterfaceProtocol**: Similar to bDeviceProtocol in the device descriptor, but for devices whose class is defined by the interface. [cmp. p. 106-108, USBC]

Endpoint Descriptor

Every endpoint that is specified in an interface descriptor has an endpoint descriptor. The standard endpoint never has a descriptor because every device must support the standard endpoint, the device descriptor contains the maximum packet size, and the USB specification defines everything else about the endpoint. Table 4 lists the endpoint descriptor's six fields in the order they occur in the descriptor. [cmp. to p 110, USBC]

Offset	Field	Size	Description
(dec)		(bytes)	
0	bLength	1	Descriptor size in bytes
1	bDescriptorType	1	The constant endpoint
2	bEndpointAddress	1	Endpoint number and direction
3	bmAttributes	1	Transfer type supported
4	wMaxPacketSize	2	Maximum packet size supported
5	bInterval	1	Maximum latency/polling interval/NAK rate

Table 5: Endpoint Descriptor [p.110, USBC]

The following descriptions group the information by function. Descriptor:

- **bLength**: The number of bytes in the descriptor.
- **bDescriptorType**: The endpoint descriptor type constant

Endpoint:

- bEndpointAddress: Contains the endpoint number and direction. Bits 0 through 3 are the endpoint number. Low-speed devices can have a maximum of 3 endpoints, while full- and high-speed devices can have 16. Bit 7 is the direction: Out=0, In=1. Bits 4, 5, and 6 are unused and must be zero.
- **bmAttributes**: Bits 0 and 1 specify the type of transfer the endpoint support. 00=Control, 01=Isochronous; 10=Bulk, 11=Interrupt. For the standard endpoint, control is assumed.
- wMaxPacketSize: The maximum number of data bytes the endpoint can transfer in a transaction. The allowed values vary with the device speed and type of transfer. Bits 10 through 0 are the maximum packet size, from 0 to 1024 (0 to 1023 in USB1.x). In USB 2.0, bits 12 and 11 indicate how many additional transactions per microframe a high-speed endpoint supports: 00=no additional transactions, 01=additional, 10=2 additional, 11=reserved. In USB 1.x, these bits were reserved and set to zero. Bits 13 through 15 are reserved and must be zero.
- bInterval: Can indicate the maximum latency for polling interrupt endpoints, the interval for polling isochronous endpoints, or the maximum NAK rate for high-speed bulk OUT or control endpoints. The allowed range and how the value is used varies with the device speed, the transfer type, and whether or not the device complies with USB 2.0.

For low-speed interrupt endpoints, the maximum latency equals blnterval in milliseconds. The value may range from 10 to 255.

For all full-speed interrupt endpoints and for full-speed isochronous endpoints on 1.x devices, the interval equals blnterval in milliseconds. For interrupt endpoints, the value may range from 1 to 255. For isochronous endpoints in 1.x devices, the value must be 1. For isochronous endpoints in full-speed 2.0 devices, values from 1 to 16 are allowed, and the interval is calculated as 2^{blnterval-1}, allowing a range from 1 milliseconds to 32768 seconds.

For full-speed bulk and control transfers, the value is ignored.

For high-speed endpoints, the value is in units of 125 microseconds, which is the width of a microframe. The value for interrupt and isochronous endpoints may range from 1 to 16, and the interval is calculated as 2^{blnterval-1} to allow a range from 125 microseconds to 4096 seconds.

For high-speed bulk OUT and control endpoints, the value indicates the endpoint's maximum NAK rate. This value is relevant when the device has received data and returned ACK, and the host has more data to send in the transfer. By returning ACK, the device is saying that it expects to be able to accept the next transaction's data. If the next data packet arrives and for some reason the device can't accept the packet, the endpoint returns NAK. The bInterval value says that the endpoint will return NAK no more than once in each period specified by bInterval. The value can range from 0 to 255 microframes. A value of zero means that the endpoint will never NAK. The host isn't required to use the maximum-NAK-rate information.

[cmp. p. 108-112, USBC]

String Descriptor

The string descriptor contains descriptive text which is not necessarily required. The descriptive strings can be used to describe the manufacturer, the product, the serial number, the configuration and the interface. Class- and vendor-specific descriptors can contain indexes to additional string descriptors. The string descriptor defines indexes to various strings. Table 5 shows the descriptor's fields and their purposes.

Offset	Field	Size	Description
(dec)		(bytes)	
0	bLength	1	Descriptor size in bytes
1	bDescriptorType	1	The constant string
2	bString or wLangID	Varies	For string descriptor 0, an array of 1 or more
			Language Identifier codes. For other string
			descriptors, a Unicode string.

[cmp. to p.112, USBC]

Table 6: String Descriptor [p.113, USBC]

Descriptor:

- **bLength**: The number of bytes in the descriptor.
- **bDescriptorType**: The string descriptor type constant

String:

When the host requires a String descriptor, the low-byte of the wValue field is an index value. An index value of zero has the special function of requesting language Ids, while other index values request strings that may contain any text.

- wLangID[0...n]: Used in string descriptor 0 only. String descriptor 0 contains one or more 16-bit language ID codes that indicate the languages that the string are available in. The code for English is 0009h, and the subcode for U.S. English is 0004h. These are likely to be the only codes supported by an operating system. The wLangID value must be valid for any of the other strings to be valid. Devices that return no string descriptors must not return an array of language IDs. The USB-IF's web site has a list of defined USB language IDs.
- **bString**: For values 1 or higher, the String field contains a Unicode string. Unicode uses 16 bits to represent each character. With a few exceptions, ANSI character codes 00h through 7Fh correspond to Unicode values 0000h through 007Fh. The strings are not null-terminated. [cmp. p. 112-113, USBC]

4.2 JTAG-Joint Test Action Group

The previous chapter described the connection between the debugger and the host. This chapter is intended to provide enough information of the IEEE Std. 1149.1 standard which is necessary to understand the operations of a debugger based on JTAG. Therefore, the test logic architecture, the signals provided by the TAP and the interconnection possibilities are necessary to explain.

4.2.1 Test Logic Architecture

This chapter should give an overview over the test logic architecture. The following elements should be included in the test logic architecture:

- a TAP (Test Access Port) described in the next chapter
- a TAP controller
- a instruction register
- and a group of data registers

In figure 2 a conceptual view of the test logic architecture is shown. This figure can be a possible embodiment of the IEEE Std. 1149.1 standard.

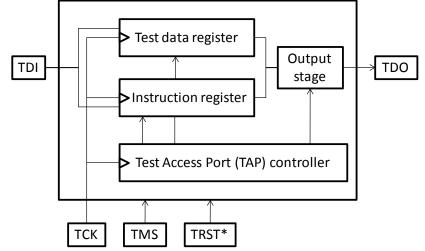


Figure 2: Test logic architecture [cmp. p.18, IEEE1149.1]

The TAP receives TCK (Test Clock) and interprets the signals on TMS (Test Mode Select). The TAP controller generates clock or control signals or both as required for the instruction and test data registers and for other parts of the architecture. The signals for the TAP controller are described in the following chapter. The assembled TAP controller signals are Test Access Port.

The instruction register allows the instruction to be shifted into the design. The instruction is used to select the test to be performed or the test data register to be accessed or both. The group of test data registers include a bypass and a boundary-scan register. It optionally can include a device identification register and further test data registers.

The optionally included output stage is necessary to choose which register content is shifted out at the TDO and to retime the signal passing through it to occur at the falling edge of TCK.

[cmp. p. 17-18, IEEE1149.1]

TAP controller

The TAP controller is a synchronous FSM (Finite State Machine) that responds to changes at the TMS and TCK signal of the TAP. It controls the sequence of operations of the circuitry. The mentioned state machine is shown in the figure below.

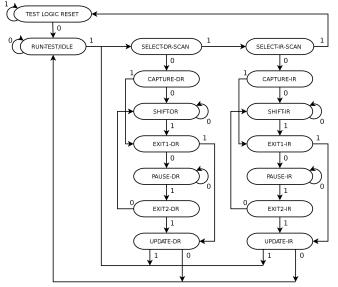


Figure 3: TAP controller state diagram [cmp. to p.19, IEEE1149.1]

The state transitions of the TAP controller state machine occurs based on the value of TMS at the time of the rising edge of TCK. Actions on the test data registers or the instruction register occurs either the rising or falling edge of TCK in each controller state. The behaviour of the TAP controller is based on the active state. In this thesis the initial states of the synchronous FSM are explained in detail. On [p.20-24, IEEE1149.1], additional or more detailed information of the states is available.

Test-Logic-Reset

In this state the test logic is disabled and the on-chip logic can operate unhindered. This is achieved by initializing the instruction register to contain the IDCODE instruction or the BYPASS instruction. If TMS is held high for at least five rising edges of TCK it is possible to enter the *Test-Logic-Reset* state from any state in the state machine (shown in figure 3). It is also possible to enter this state, if 0 is applied to TRST*. If the *Test-Logic-State* is left the *Run-Test/Idle* state is reached.

[cmp. p.20, IEEE1149.1]

Run-Test/Idle

In this state, activity in selected test logic occurs only when certain instructions are present. For example the RUNBIST instruction causes a self-test of the on-chip system logic to execute in this state. The instruction does not change while he TAP controller is in this state. The controller will remain in this state as long as TMS is kept low. If TMS is logic 1 and a rising edge is applied to TCK the controller will change either in the *Select-DR-Scan*

state if one rising edge occurs or in the *Select-IR-Scan* state if two rising edges on TCK occur. [cmp. p. 20, IEEE1149.1]

4.2.2 Test Access Port (TAP)

The Test Access Port is a general-purpose port that can provide access to many test support functions built into a component. The TAP provides a minimum of three input connections and one output connection. An optional fourth input connection provides for asynchronous initialization of the test logic. This chapter focuses on the mentioned I/O signals and their functionality. [cmp. p. 9, IEEE1149.1]

The TAP includes the following signals:

- TCK-Test Clock Input
- TMS-Test Mode Select Input
- TDI-Test Data Input
- TDO-Test Data Output
- TRST*-Test Reset Input (optional)
 - $\circ~$ If the TAP controller is not reset at power-up automatically, a TRST* input should be provided

The following paragraphs should explain the signals in detail.

TCK-Test Clock Input

This input is required to be able to use the serial test data path between the components independently of the component-specific system clocks. It also permits shifting of test data concurrently with normal system operation of the component. An independent clock ensures that test data can be moved to or from a chip without changing the state of the on-chip system logic. The independent clock is also important if the boundary-scan registers should be usable for board interconnect testing.

The test clock should be a free-running clock with a 50% duty-cycle which can be stopped in some situations for a period. The JTAG standard requires that the TCK can be stopped at 0 indefinitely without causing any change to the state of the test logic. Due to the stopped clock it is necessary that the connected devices retain their state so that the test logic may continue when the clock operation restarts.

The test logic performs their operations at the rising or falling edge of the test clock. This operations have to be completed within a fixed (frequency independent) delay after the occurrence of the relevant change of the TCK. This delay has o be specified by the component supplier.

[cmp p.10-11, IEEE1149.1]

TMS-Test Mode Select Input

The signal received at TMS is decoded by the TAP controller to control operations. The signal at the TMS is sampled at the rising edge of the test clock. The load at TMS should be as small as possible.

The TAP controller should be forced into the *Test-Logic-Reset* controller state if the TMS pin is undriven. This ensures that normal operation of the complete design can continue without interference from the test logic. If TTL-compatible designs are used, this implies that a pull-up resistor is connected to the TMS line.

It is expected that the bus master - in this project this is the CMARMJTAG - will change the signal driven to the TMS inputs of connected components on the falling edge of TCK. [cmp p. 11, IEEE1149.1]

TDI-Test Data Input

Serial test instructions and data are received by the test logic at TDI. The signal at TDI should be sampled on the rising edge of TCK. Data which is propagated from TDI to TDO without inversion is necessary to simplify the operations of a compatible component. The values which are received at the TDI are clocked into the selected registers (instruction or test data) on the rising edge of TCK. For TTL-compatible designs it is necessary to connect a pull-up resistor on the components TDI pin.

[cmp. p. 12, IEEE1149.1]

TDO-Test Data Output

TDO is the serial output for test instructions and data from the test logic. A change of the signal at TDO should only occur at the falling edge of TCK. To ensure race-free operation, changes on the TAP inputs (TMS & TDI) are clocked into the test logic at the rising edge of TCK while changes at the TAP output (TDO) occur on the falling edge of TCK. The ability to switch between active and inactive drive is required to allow parallel, rather than serial, connection of board-level test data paths in cases where this is required. In TTL or CMOS technologies this requirement can be met through use of a 3-state output buffer. [cmp. p. 12, IEEE1149.1]

TRST*-Test Reset Input

The optional TRST* provides the ability to asynchronous initialize or reset the TAP controller. If a TRST* is supported by the TAP, the TAP controller should be able to enter the *Test-Logic-Reset* controller state asynchronously, when a logic 0 is applied to TRST*. To ensure deterministic operation of the test logic, TMS should be held at 1 while the signal applied at TRST* changes from 0 to 1 to ensure that the test logic responds predictably. If rising edges occur simultaneously at TRST* and TCK when a logic 0 is applied to TMS, a race will occur, and the TAP controller may either remain in the *Test-Logic-Reset* controller state or enter the *Run-Test/Idle* controller state.

For TTL-compatible designs it is necessary to connect a pull-up resistor to TRST* to ensure that in case of a non-terminated TRST* input, test logic operation can proceed under control of signals applied at the TMS and TCK inputs. It is also possible to disable the test logic by hard-wiring TRST* to logic 0.

[cmp. p. 13, IEEE1149.1]

4.2.3 Interconnection of components

The previous chapter gave an overview of the signals and defined their requirements and rules according to the IEEE Std. 1149.1 standard. This chapter specifies on the possibilities to interconnect the components compatible to this standard.

Figure 4, figure 5 and figure 6 illustrate three alternative board level interconnections of components. In each example, the test bus can be controlled by a component that provides an interface to a test bus at the next level of assembly. In this project the device that controls the board-level test bus is referred to as the bus master (CMARMJTAG). Figure 4 contains the minimum required signals which are necessary to assemble a serial path formed by a daisy-chain connection of the serial test data pins (TDI & TDO).

[cmp. p. 14, IEEE1149.1]

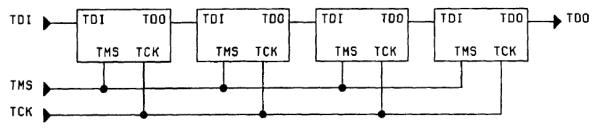


Figure 4: Serial connection using one TMS signal [p. 14, IEEE1149.1]

Figure 4 shows four JTAG-compatible devices which are serial connected. In this project the bus slave can be any controller which is supported by OpenOCD. The JTAG signals (TDI, TMS, TCK, TDO) are provided by the CMARMJTAG which acts as a bus master. Additionally the bus master optionally offers a TRST*, as described in the previous chapter, which is not shown in figure 4.

The hybrid serial/parallel connection, shown in figure 5, uses a pair of coordinated TMS signals (TMS1 & TMS2) to ensure that only one serial path is scanning data at a given time.

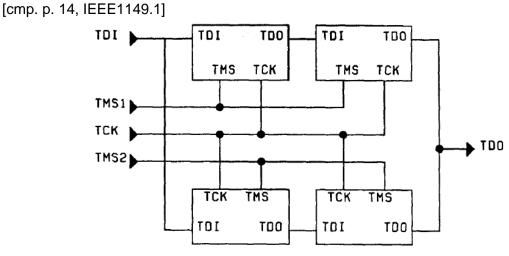


Figure 5: Connection in two paralleled serial chains [p. 14, IEEE1149.1]

The 3-state output buffer of TDO is used to ensure that only the components that are scanning data have TDO in the active drive state.

Figure 5 shows how to interconnect four bus slaves using multiple independent paths with common TMS and TCK signals.

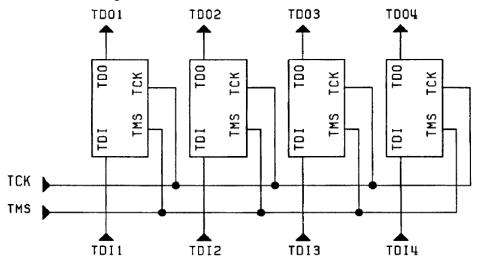


Figure 6: Multiple independent paths with common TMS & TCK sig. [p. 15, IEEE1149.1]

These paths have separate TDI and TDO signals but can be controlled from common TCK and TMS signals. When choosing a configuration for the board-level interconnection of components conforming to the IEEE Std. 1149.1 standard, it is necessary to consider the capability of test equipment and test pattern generators. It is fully expected that any test equipment and/or test pattern generators that intends to support a test methodology based on the boundary-scan architecture would be able to test the board-level configuration of figure 4, since the degenerated form of this configuration is a single conformant component. Furthermore, some test equipment and/or test pattern generators may not be able to test the board-level configurations of figure 5 and figure 6. [cmp. p. 14, IEEE1149.1]

5 OpenOCD-Open On-Chip-Debugger in a nutshell

The previous chapters described the interfaces which are used in this project. This chapter explains the program running on the host, shown in figure 1, which uses the USB interface. This chapter gives a basic overview on OpenOCD and is not intended to explain the details. In [3] OpenOCD is explained in detail. Figure 7 shows the host configuration which is used in this project.

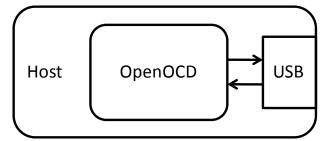


Figure 7: Host configuration

OpenOCD runs as a daemon process on the host workstation, making use of a JTAG compliant hardware interface that connects to the target system.[cmp. p.32, OOCD05] This process provides two USB endpoints. One endpoint is configured for input communication and the other endpoint controls the output communication. The endpoints are connected to the USB peripheral of the CMARMJTAG which converts the USB commands provided by OpenOCD into commands which are transferred to the JTAG interface of the target system. The CMARMJTAG also converts the JTAG responds of the target system into USB commands readable for OpenOCD.

OpenOCD is able to load the code in the target memory, to control code execution on the target and examine the target state. [cmp. p. 32, OOCD05]

If there is no code on the target it is necessary to perform initial steps to be able to load the code in the target memory. OpenOCD provides commands to set up the configuration of the target to be able to transfer the compiled code. OpenOCD supports many different flash devices and enables the user to add devices.

Supported Flash devices:

- AT91SAMxxxx from ATMEL
- i.MXxx from Freescale
- LM3Sxxxx from LuminaryMicro
- LPCxxxx from NXP
- OMAPxxxx from Texas Instruments
- S3Cxxxx from Samsung
- STxxxx from STMicroelectronics

OpenOCD offers a possibility to integrate additional JTAG hardware interfaces like the CMARMJTAG and it is possible to change the amount of the debug information during runtime to allow a developer to examine the debugger's behaviour during selected

operations. A configuration file and command line arguments are used to configure the debugger. It is possible to select configuration files via command line arguments, to give the developer the ability to debug multiple targets or multiple configurations, without change or replace the configuration file every time.

[cmp. p.32, OOCD05]

The command line interface uses a telnet server embedded in the debugger. The developer can connect to the server process using a telnet client. This allows a single debug system to be used by different users at remote locations. Via the configuration file it is possible to configure the telnet port. If no telnet port is specified, port number 4444 is used.

It is also possible to determine a GDB (GNU Debugger) port for OpenOCD. The standard GDB port number is 3333. Due to this port OpenOCD offers an interface to the GDB. It is possible to use standard GDB commands to configure the target.

Supported GDB commands:

- Poll target state
 - o retrieves information about the current target states.
- Architecture state
 - o retrieves architecture specific information about the current target state
- Halt
 - forces the target into debug state; after halting the target it is possible to examine and modify the target state
- Resume
 - makes the target leaving the debug state; target starts executing at the point where it was halted
- Step
 - o target executes exactly one instruction
- Reset
 - this resets all system functionality, but leaves the debugger in control of the target; it is possible to halt the target after coming out of reset; if no halt occurs the target starts executing from the reset vector
- Set/Get GDB registers
 - o it is possible to set and get the content of the core registers
- Read/Write memory
 - o it is possible to perform 8-, 16-, or 32-bit accesses to the internal memory of the target; e.g. monitor mwb 0xXXXXXXX 0x00 → this command means Memory Write Byte [Target Address] [Value]
- Add/Remove breakpoints
- Add/Remove watchpoints

[cmp. p.34-35, OOCD05]

OpenOCD supports four different levels of debug information.

- Error messages which are fatal for the program's further execution. Code in OpenOCD → LOG_ERROR
- Warnings that indicate a problem, but allow the program to continue execution.
 Code in OpenOCD → LOG_WARNING
- Informational messages that are generated during normal program execution. These messages give the user additional information about the debuggers operation. Code in OpenOCD $\rightarrow LOG_INFO$
- Debug messages, which may occur at a high rate. These messages are used to identify problems during further development of the debugger. Code in OpenOCD → LOG_DEBUG

[cmp. p. 38, OOCD05]

In the following chapters there are many topics dealing with OpenOCD. Therefore, this chapter highlighted basic functionalities and features.

6 Cortex-M3 core - an overview

The previous chapter focused on the features and functionalities of OpenOCD which runs on the host workstation. To be able to connect the target hardware to the PC the CMARMJTAG is used. As explained, this device consists of an ARM Cortex-M3. This chapter explains the most important functionalities and features of the Cortex-M3 core. The document [4] provides more detailed information about the core functionality and is used as basis of this chapter.

The Cortex-M3 core is a 32-bit microprocessor which has a 32-bit data-path, a 32-bit register bank and a 32-bit memory interface. This microprocessor is a Harvard architecture, which means it has a separate instruction bus and data bus. The instruction and data buses share the same memory space. The Cortex-M3 core supports both little endian and big endian memory systems. Figure 8 shows a conceptual overview of the core.

[cmp. p. 13, GCM307]

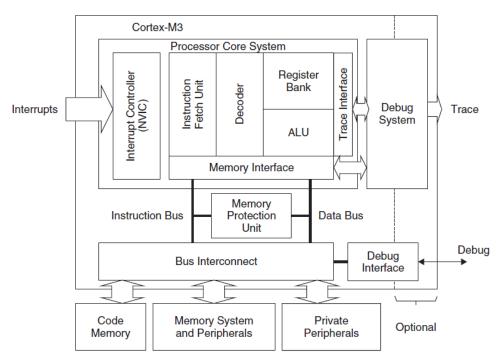


Figure 8: A conceptual view of the Cortex-M3 core [p. 14, GCM307]

The functionality of the built-in components of the CM3 (Cortex-M3) core are explained step by step in the following chapters.

Core Registers

The CM3 processor has the core registers R0-R15. R0-R12 are general purpose registers for data-operations. The CM3 core contains two stack pointers, R13. These two pointers are banked which implies that only one is visible at a time. The MSP (main Stack Pointer) is the default stack pointer and is used by the OS kernel and the exception handlers. The PSP (Process Stack Pointer) is used for user application code. If a subroutine is called the return address is stored in the link register R14. The program counter is stored in R15. Some special registers are also available in the CM3 core. The xPSR register contains the ALU flags, e.g. zero flag, carry flag, execution status etc. The PRIMASK register enables the developer to disable all interrupts expect the NMI (non-maskable interrupt) and HardFault. The FAULTMASK register is used to disable all interrupts of specific priority level or lower priority level. The CONTROL register defines the privileged status and stack pointer selection. [cmp. p. 15-16, GCM307]

Operation Modes

The CM3 core has two operation modes and two privilege level. If the processor comes out of reset it is in Thread Mode, with privileged access rights. In the privileged state a program has access to all memory ranges. If the CM3 core runs at privileged access level it is possible to write to the control register to switch the mode. If an exception is thrown the processor switches into privileged access level and returns back to the previous access level after execution of the exception. To be able to adjust the control register it is necessary for a user program to go through an exception to program this register. This separation of the access levels is necessary to improve systems reliability and to prevent system configuration registers from being accessed or changed by some untrusted programs.

[cmp. p. 16-17, GCM307]

NVIC-Nested Vectored Interrupt Controller

The NVIC is closely coupled to the CM3 core and provides a number of features which are explained in this section.

[cmp. p.17, GCM307]

Nested Interrupt Support

It is possible to define different interrupt priority levels to the external interrupts and to most internal system exceptions. The NVIC compares the priority of the occurred interrupt to the currently running priority level. If the occurred interrupt has a higher priority than the currently running interrupt the processor will override the current running task. [cmp. p.17, GCM307]

Vectored Interrupt Support

The starting addresses of the interrupt service routines (ISR) are located in the vector table in the memory. There is no need to use software to determine and branch to the starting address of the ISR which means that it takes less time to process an interrupt request. [cmp. p.17, GCM307]

Dynamic Priority Changes Support

The priority levels of interrupts can be changed by software during execution. Interrupts which are defined are blocked from activation until the ISR is completed. There is no risk of accidental re-entry.

[cmp. p.17, GCM307]

Reduction of Interrupt Latency

The CM3 core includes a number of features to lower the interrupt latency. These features are including automatic saving and restoring some register contents, reducing delay from switching from one ISR to another and handling late arrival interrupts.

[cmp. p.17, GCM307]

Interrupt Masking

It is possible to mask interrupts and system exceptions based on their priority level or using the interrupt mask registers BASEPRI, PRIMASK, and FAULTMASK. This ensures that time-critical tasks can be finished on time without being interrupted. [cmp. p.17, GCM307]

The Memory Map

The CM3 has a predefined memory map which means that the built-in peripherals can be accessed via simple memory access instructions. The memory map gives the CM3 the ability to be optimized for speed and it is easier to integrate the core in system-on-a-chip (SoC) designs. Figure 9 shows the 4GB memory space of the CM3 core. [cmp. p.19, GCM307]

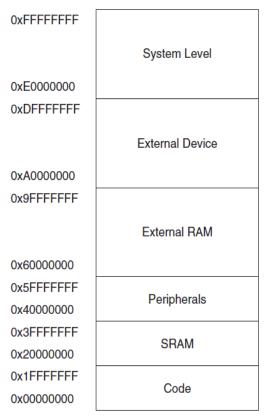


Figure 9: The CM3 Memory Map [p.19, GCM307]

The System Level memory space includes the private peripherals like the NVIC, the Memory Protection Unit (MPU) registers and the debug components. The External Device section includes the external peripherals and the External RAM section is used for external memory. The SRAM section is used for internal static RAM and the Code section includes the user program code and the exception vector after power-up. The System Level memory region makes it easy to port applications between different CM3 products. [cmp. p. 19, GCM307]

The Bus Interface

As shown in figure 8 the CM3 provides a code memory bus, which physically consists of two buses. One bus is called I-Code (Instruction Bus) and the other is called D-Code (Data Bus). This bus is optimized for best instruction execution speed. The system bus is used to access memory and peripherals which provides access to the SRAM peripherals, external RAM, external devices and a part of the System Level memory region. For example the debugging components and the NVIC are accessed through the private peripheral bus. [cmp. p. 20, GCM307]

The Memory Protection Unit-MPU

The MPU enables the developer to set up rules for privileged access and user program access. If a rule is violated, a fault exception is generated and it is possible to analyze the problem in the fault exception handler.

Commonly the MPU is used and set up by an operating system, which can define the rule that the OS kernel is able to access privileged data and registers. The MPU can also be used to make memory regions read-only, to prevent accidental erasing of data.

The MPU feature is optional and is determined during the implementation stage of the microcontroller or SoC design.

[cmp. p. 20, GCM307]

Debugging Support

The debugging hardware of the CM3 is based on the CoreSight architecture. Instead of the built-in JTAG interface the CM3 includes a decoupled debug interface module and a bus interface called Debug Access Port (DAP) on core level. The DAP enables external debuggers to access control registers as well as system memory. The bus interface is controlled by the Debug Port (DP) device. There are three integrable DP modules:

- SWJ-DP
 - o Supports the JTAG protocol as well as the Serial Wire protocol
- SW-DP
 - Supports the Serial Wire protocol
- JTAG-DP
 - Supports the JTAG protocol

The manufacturer can also include an Embedded Trace Macrocell (ETM) which allows instruction trace. This information is output via the Trace Port Interface Unit (TPIU) and the host workstation can collect the executed instructions via an external trace-capturing hardware.

[cmp p.24, GCM307]

7 Specific project setup

The previous chapters focused on the theoretical basics of the essential parts of the basic project configuration, shown in figure 1. The interfaces JTAG and USB where explained and an overview of the CM3 core operations were given.

This chapter gives an overview of the specific project configuration. Figure 10 shows the specific project configuration which is used in this project.

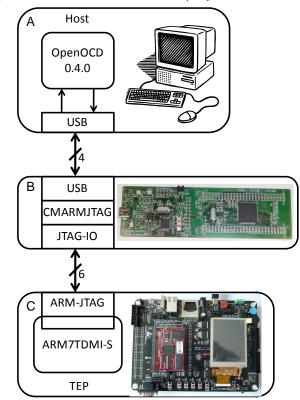


Figure 10: Specific Project Configuration

Part A of figure 10 illustrates the host workstation, the OpenOCD and the USB interface. The workstation (Host) is equipped with Ubuntu¹⁵ 10.4 LTS, a state-of-the-art Integrated Development Environment (IDE) and OpenOCD 0.4.0 adapted and compiled for the CMARMJTAG. As IDE, Eclipse¹⁶ Galileo with the GNU ARM and Zylin Embedded CDT plug-ins is used.

Part B of figure 10 shows the prototype of the CMARMJTAG which consists of an ARM Cortex-M3 from NXP called LPC1768. This evaluation board initially was designed to fit onto the baseboard from EmbeddedArtists¹⁷ which provides many external peripherals for microcontrollers based on ARM cores. Additionally the JTAG pins of the LPC1768 are

¹⁵ http://ubuntuusers.de/

¹⁶ http://www.eclipse.org/

¹⁷ http://www.embeddedartists.com/

connected to an external debugger based on the FTDI chip. The external debugger is used to load and debug the firmware for the CMARMJTAG to the LPC1768. This debugging feature enables the developer to precisely design the code for this project.

The LPC1768 is able to provide a CPU clock up to 100MHz and provides 512kB internal Flash memory and 64kB internal SRAM. This μ C also has a built-in USB peripheral which is used to communicate with the host workstation. The JTAG-IO interface is not the built-in JTAG interface of the μ C. This interface consists of general purpose I/O pins (GPIOs) which are "simulating" a JTAG interface.

Part C of figure 10 shows the Target Embedded Platform (TEP) from EmbeddedArtists. The TEP consists of an ARM7TDMI-S from NXP called LPC2478. This Embedded Platform provides many external peripherals like a Touch Screen Display, a SD-Card Slot, an Ethernet connector, a USB Host/OTG/Device interface, etc. The JTAG interface, called ARM-JTAG in figure 10, is also available on the TEP. This interface is connected to the JTAG-IO interface of the CMARMJTAG.

8 Implementation

The previous chapter has given an overview of the specific project configuration. This chapter explains the details of the implementation, describes how to integrate a new interface into OpenOCD, explains the driver which handles the JTAG commands and configures the USB device. Finally the USB firmware library is explained.

8.1 Integration of a new interface into OpenOCD

To be able to compile OpenOCD for the CMARMJTAG it is necessary to modify some files in the standard OpenOCD source tree. This chapter describes how to integrate a new interface into OpenOCD. The following files have to be edited to enable the interface for compilation. The root (.) directory is openocd-0.4.0/.

- a) ./configure.in
- b) ./configure
- c) ./config.h
- d) ./README
- e) ./doc/openocd.texi
- f) ./src/Makefile.in
- g) ./src/Makefile.am
- h) ./src/jtag/interfaces.c
- i) ./src/jtag/drivers/Makefile.in
- j) ./src/jtag/drivers/Makefile.am
- k) ./src/jtag/drivers/Makefile

Additionally it is necessary to add a driver file to implement the interface specific routines and to add a basic configuration file for the interface. The interface driver has to be added to ./src/jtag/drivers/. Currently the CMARMJTAG driver is included and named *cmarmjtag.c*. The structure of the driver and the functionalities of the included routines are explained in chapter 8.2. The interface configuration file has to be added to ./tcl/interface/. In this project there already exists a configuration file named *cmarmjtag.cfg*. To ease the integration process of a new interface a patch file is used to auto-integrate the new contents. This patch file is also available in the thesis folder.

8.2 OpenOCD driver description

The previous chapter described how to register a new interface into the standard OpenOCD source tree. To be able to access the USB port on the host workstation where the CMARMJTAG is connected and to execute and set up the proper JTAG commands based on the JTAG state machine, it is necessary to develop a driver which provides these functionalities. This chapter describes the structure of the CMARMJTAG driver and explains the most important C-routines of it.

If the JTAG-Debugger is attached to the host, an initial registering procedure is performed. During this procedure the host reads out the required information to locate and enable the new USB device. The device descriptor on the CMARMJTAG provides this information. To check whether the USB device is registered correctly it is necessary to execute the *lsusb* -v / *-less* in the command shell. The following lines show the output for the

CMARMJTAG.

Bus 005 Device 008: 1	ID ffff:	:0005
Device Descriptor:		
bLength	18	
bDescriptorType	1	
bcdUSB	2.00	
bDeviceClass	255	Vendor Specific Class
<i>bDeviceSubClass</i>	0	
bDeviceProtocol	0	
bMaxPacketSize0	64	
idVendor	0xffff	
idProduct	0x0005	
bcdDevice	1.00	
iManufacturer	1	FHTW
iProduct	2	CMARMJTAG
iSerial	3	0000:00:1
bNumConfigurations	1	

Listing 1: Device Descriptor (console output)

Listing 1 shows the retrieved device descriptor. The vendor identification (VID) and product identification (PID) is configured to 0xffff and 0x0005. These two parameters are necessary to identify the USB device in the CMARMJTAG driver. The manufacturer string, the product string and the serial string are configured via the descriptor in the CMARMJTAG firmware. This device descriptor supports one configuration.

Configuration Descript	cor:	
bLength	9	
bDescriptorType	2	
wTotalLength	60	
bNumInterfaces	1	
bConfigurationValue	1	
iConfiguration	0	
bmAttributes	0x80	
MaxPower	100mA	

Listing 2: Configuration Descriptor (console output)

Listing 2 shows the configuration descriptor of the USB device on the external debugger. The descriptor type field enables the host to identify this descriptor as the configuration descriptor. This configuration descriptor supports one interface and the configuration index is configured to 0. The attributes value indicates that the device is bus powered which means that the host acts as the power supply for the USB device on the CMARMJTAG. The configuration descriptor in the CMARMJTAG firmware configures the power field to 0x32 which means 100mA. For the current project configuration the provided current is adequate. The maximum value for this field is 0xFA: This value is 250_{dec} and configures the USB device to 500mA.

Interface Descriptor:					
bLength	9				
bDescriptorType	4				
bInterfaceNumber	0				
bAlternateSetting	0				
bNumEndpoints	2				
bInterfaceClass	255 Ven	dor S	Specific	Class	
bInterfaceSubClass	0				
bInterfaceProtocol	0				
iInterface	0				

Listing 3: Interface Descriptor (console output)

Listing 3 shows the interface descriptor of the CMARMJTAG USB device. This interface supports no alternate setting and provides two endpoints which are configured in the endpoint descriptor (Listing 4). The interface index is configured to 0.

Endpoint Descriptor:		
bLength	7	
bDescriptorType	5	
bEndpointAddress	0x05	EP 5 OUT
bmAttributes	2	
Transfer Type		Bulk
Synch Type		None
Usage Type		Data
wMaxPacketSize	0x0168	1x 360 bytes
bInterval	0	
Endpoint Descriptor:		
bLength	7	
bDescriptorType	5	
bEndpointAddress	0x82	EP 2 IN
bmAttributes	2	
Transfer Type		Bulk
Synch Type		None
Usage Type		Data
wMaxPacketSize	0x0168	1x 360 bytes
bInterval	0	

Listing 4: Input / Output Endpoint Descriptor (console output)

The endpoint descriptor, shown in Listing 4, is necessary to configure the required endpoints of the USB device. The first endpoint is an out endpoint.

The communication direction is configured from the host point of view. This means via the out endpoint on the host, data can be written to the CMARMJTAG. The out endpoint of the USB device of the external debugger is configured to address 0x05. But the CMARMJTAG receives data via this endpoint.

The read endpoint of the host receives data from the external debugger. But the read endpoint of the CMARMJTAG sends data to the host. The out endpoint address is configured to 0x05 and the transfer type is configured to bulk transfers. The out endpoint is used to transfer data and has a maximum packet size of 360 bytes because during a debugging session no more than 360 bytes are transmitted via the TDO pin.

The second endpoint is an in endpoint or read endpoint. This endpoint has the address 0x82. The read endpoint transfer type is configured to bulk transfer and is able to transfer a maximum of 360 bytes in a packet. The packet length is the same length as the buffer size of the external debugger.

Device	Status:	0x0000
(Bus	Powered)	

Listing 5 shows the device status. After attachment of the USB device and successful registration the device status should be 0x0000. In the CMARMJTAG driver there are some *#defines* which are necessary to provide parameters for the USB device on the host and to determine the speed limits of the JTAG clock. The interface mapping between the standard OpenOCD low-level functions is done via the interface structure shown in Listing 6.

<pre>struct jtag_interface cmarmjtag_interface =</pre>
{
.name = "cmarmjtag",
.commands = cmarmjtag_command_handlers,
.execute_queue = cmarmjtag_execute_queue,
.speed = cmarmjtag_speed,
.speed_div = cmarmjtag_speed_div,
.khz = cmarmjtag_khz,
.init = cmarmjtag_init,
.quit = cmarmjtag_quit,
};

Listing 6: CMARMJTAG interface structure (code snippet)

This interface structure enables the developer to implement interface specific functions accessible via OpenOCD. Figure 11 gives an overview of the CMARMJTAG driver structure. The routines *speed()* and *speed_div()*, shown in Listing 6, are present in the driver but not used. Thus these routines do not appear in figure 11.

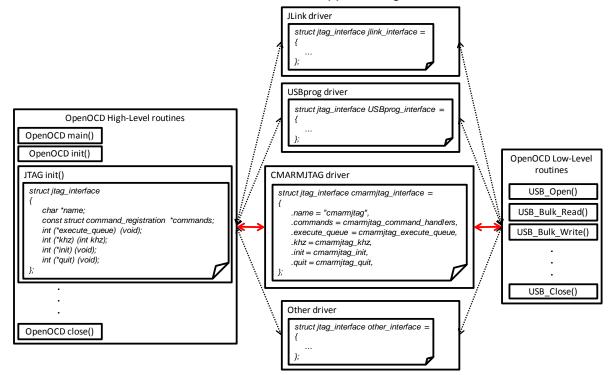


Figure 11: CMARMJTAG Driver Overview

The principle structure of the driver is determined by the external interface routines shown in Listing 6. The init routine opens the attached USB device. This routine initializes the USB device of the host, loads the busses and the devices and locates the USB device due to the VID and PID parameter, which are defined in the driver. The <u>usb_open()</u> routine returns a structure which holds the configuration of the attached USB device. Via this structure it is possible to communicate with the external debugger (USB device). After the USB device configuration is set up a reset message is sent to the CMARMJTAG.

The *cmarmjtag_reset()* routine induces the CMARMJTAG to perform a reset sequence via the TRST_N pin and the SRST_N pin. The reset function calls the *cmarmjtag_simple_command()* routine which is used to send messages and receive the reply with a command header. The low-level routines *cmarmjtag_usb_write()* and *cmarmjtag_usb_read()* are necessary to send the data provided by the *usb_out_buffer[]* and *usb_in_buffer[]* array. Figure 12 shows the configuration of one USB frame.

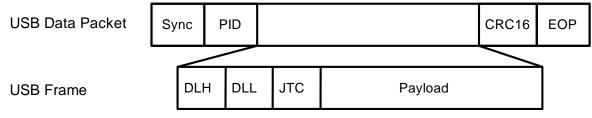


Figure 12: USB Frame configuration

The USB frame provides information about the payload length and the JTAG command which has to be performed and the payload itself. The payload length is divided into two bytes. The payload length can vary between 0 and 357 bytes. The first byte of the USB frame, shown in figure 12, provides the high-byte of the payload length (DLH). The second byte of this frame illustrates the low-byte of the USB frame. The third byte contains the JTAG command which has to be performed. The following JTAG commands are possible:

- JTAG_CMD_TAP_OUTPUT 0x1
 - The payload contains the values which are set & reset the TDI, TMS pins and the value for the single pin is extracted on the CMARMJTAG.
- JTAG_CMD_SET_TRST 0x2
 - o Disable TAP Reset. Enable TAP.
- JTAG_CMD_SET_SRST 0x3
 - o Disable software reset.
- JTAG_CMD_READ_INPUT 0x4
 - Read the data on the TDO pin.
- JTAG_CMD_TAP_OUTPUT_EMU 0x5
 - This command is not supported on the CMARMJTAG in this project.
 - JTAG_CMD_SET_DELAY 0x6
 - o Adjust the JTAG speed in kHz.

JTAG_CMD_SET_SRST_TRST 0x7

 Disable TAP Reset, enable TAP and disable software reset simultaneously The amount of transmitted & received bytes are stored in a variable which is used to check whether the transmission was successful or not. After the reset is performed the TAP is initialized.

In the *cmarmjtag_execute_queue()* routine proper subroutines are provided to implement different commands.

The *cmarmjtag_runtest()* routine performs a given amount of JTAG state steps, if the JTAG state machine is not already in the idle state. Within this routine the TAP Buffer routine *cmarmjtag_tap_append_step()* is called to perform the determined steps. The *cmarmjtag_end_state()* function checks whether the JTAG state machine of the target μ C is in an valid end state or not.

The *cmarmjtag_state_move()* routine moves the JTAG state machine of the debugged hardware to the next state that valid.

The *cmarmjtag_path_move()* routine performs a number of steps in a defined path of the JTAG state machine.

The *cmarmjtag_scan()* routine scans the connected JTAG chain and performs the required state transitions to complete the task.

The reset command during the execution of the queue controls the attached JTAG chain and performs a reset afterwards.

The *cmarmjtag_tap_execute()* function prepares the values for the USB buffer. The JTAG command JTAG_CMD_TAP_OUTPUT is signalling that the payload contains a new TAP sequence. The answer on this payload is transmitted via USB to the host workstation and is stored in the *usb_in_buffer[]*. At the end of the sequence the content of the *usb_in_buffer[]* is copied to the *tdo_buffer[]* which stores the information for further operations.

The *jtag_sleep()* routine is a member of the core routines, which means that this function calls a core routine located in *core.c*.

The *cmarmjtag_khz()* routine is one of the members of the external interface routines. This function checks whether the desired speed value is between the borders of the speed limit and checks whether the value can be divided by 100 without a remainder. The CMARMJTAG supports speeds from 100 kHz till 2000 kHz. These limits are defined at the top of the driver file and shown in Listing 7.

#define CMARM_MAX_SPEED	2000	
#define CMARM_MIN_SPEED	100	

Listing 7: CMARMJTAG supported speed limits (code snippet)

The step size of the speed should be 100 kHz. If the speed is above the upper limit of the speed, this routine sets the speed to the upper limit. If the speed is below the lower limit of the supported speed, this routine sets the speed to the lower limit. If the desired speed is

not dividable by 100 the *cmarmjtag_khz()* routine sets the speed to next slower speed. For example, if the desired speed is 1425 kHz, the driver sets the speed to 1400 kHz.

8.3 CMARMJTAG firmware description

The previous chapter focused on the implementation of the driver on the host workstation. As described in chapter 8.2 the USB device peripheral on the CMARMJTAG has to be configured correctly, that the host can retrieve the required information and set up a USB communication. This chapter describes the firmware which is used in this project and runs on the LPC1768. Additionally this chapter gives an overview of the firmware structure, lists the used development tools and add-ons and explains important configuration parameters and functions.

The FTDI-based debugger which is connected to the LPC1768 enables the developer to download and debug the written firmware. Figure 13 shows a prototype of the CMARMJATG used in this project.

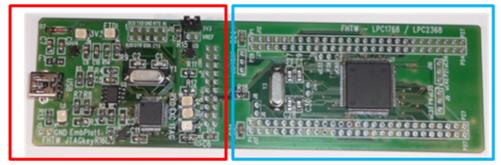


Figure 13: Prototype of the CMARMJTAG

The red rectangle of figure 13 shows the FTDI-based debugger. This debugger provides a (Mini-) USB interface to the host workstation. This debugger consists of a FT2232D, an external EEPROM (M93C46) and passive components. The FT2232D provides a JTAG interface and a RS232 interface for the μ C. The FT2232D can be supplied via USB or via the supply voltage of the target μ C. In this project the USB supply voltage is used. To be compatible to the voltage range of the μ C pins it is necessary to supply the FT2232D with the corresponding voltage. Therefore, if the USB supply voltage is used, an external voltage regulator is used.

The blue rectangle shows the μ C (in this project an ARM Cortex-M3 LPC1768 from NXP), the external oscillator (12MHz) and the μ C pins which are connected to external pin connectors.

This debugger is connected via USB to the host workstation. If the USB connection is established it is possible to access the μ C via USB. At the host workstation the USB port appears as a device named FHTW JTAGKey. This enables the developer to connect to the μ C via OpenOCD and start firmware developing.

To be able to communicate with the USB peripheral of the CM3 it is necessary to connect it properly. Figure 14 shows the schematic which is used to connect the USB connector to the USB peripheral of the CM3.

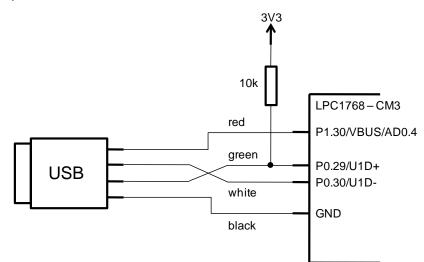


Figure 14: USB connection schematic

The standard USB connector provides four wires. Table 7 gives an overview of the USB signals their pin number on the USB connector and a short description.

Pin	Name	Colour	Description
1	VCC	red	+5V
2	D-	white	Data -
3	D+	green	Data +
4	GND	black	signal ground

Table 7: USB signals and description

The CMARMJTAG firmware is stored in an Eclipse project named "ARMJTAGDebugger". The structure of the project is shown in figure 15.

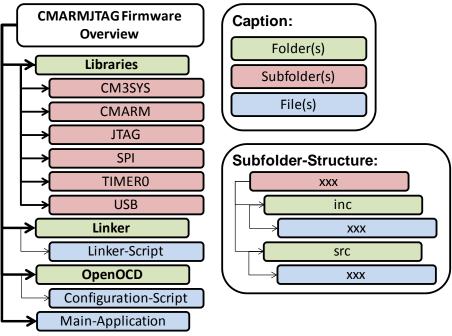


Figure 15: CMARMJTAG Firmware Overview

The "Libraries" folder contains subfolders which are providing *.c and *.h files for the corresponding peripherals and for the core itself. Every subfolder has the same internal structure. This structure is also shown in figure 15 (Subfolder-Structure). It contains a inc (include) folder and a src (source) folder. In the next chapters the content of the subfolder is explained.

8.3.1 CM3SYS subfolder description

The CM3SYS subfolder contains the routines which are necessary to initialize the μ C-core, to configure the Vectored Interrupt Controller (VIC), to set up the Phase Locked Loop (PLL) and to configure the peripheral clock (PCLK). Five source files are located in *CM3SYS\src* to provide the routines for these purposes:

- a) startup_LPC17xx.s
- b) core_cm3.c
- c) system_LPC17xx.c
- d) lpc17xx_nvic.c
- e) NVICInit.c

The file startup_LPC17xx.s

This file defines the interrupt vector table for the core exceptions and interrupts and for the external interrupts. The external interrupt sources are the peripherals of the CM3, e.g. Timer, UART, SPI, etc. The core exception handlers are implemented as endless loops. The default handler is called if an interrupt on the Nested Vectored Interrupt Controller (NVIC) is raised. To be able to branch to the registered interrupt handler of the corresponding peripheral it is necessary to identify the interrupt source and the according

interrupt handler (IRQHandler). Additionally during the execution of the startup code various routines are called to initialize the system. Listing 8 shows a sample branch sequence in the startup code.

LDR	R0, =SystemInit
BLX	RO

Listing 8: Branch sequence in the startup code (code snippet)

These assembler lines are necessary to branch (call) the *SystemInit* routine. The content and functionality of this routine are explained in c). The startup code branches to three different routines. As shown in Listing 8 to the *SystemInit* routine, additionally to the *NVICInit* routine, described in e) and finally to the *main* routine.

The file core_cm3.c

This file defines compiler specific symbols shown in Listing 9, and defines compiler specific intrinsics.

#if defined (CC_ARM)
#defineASMasm	/*!< asm keyword for ARM Compiler */
#defineINLINEin	line /*! <inline *="" <="" arm="" compiler="" for="" keyword="" th=""></inline>

Listing 9: Compiler specific symbols (code snippet)

None of these compilers are used in the current project configuration which means that most parts of this file are not included in the compile process.

The file system_LPC17xx.c

This file is necessary to provide the routines for the initialization of the system, including the calculation of the core clock (CCLK), the configuration of the PLL and the configuration for the PCLK. The *SystemInit* routine is called within the startup code execution. In this file the c-code for this routine is implemented. This function has no parameters because all configurations are done via defines located in this file.

After reset, if nothing else is configured via the configuration script of OpenOCD, the core operates on a frequency of 4MHz provided by the internal oscillator. If the macro *CLOCK_SETUP* is enabled and an external oscillator is connected to the XTAL pins of the µC the value of the System Control and Status (SCS) register redirects the clock source to the external oscillator. The values for the Peripheral Clock Selection registers 0/1 (PCLKSEL0/1) are provided via macros (*PCLKSEL0_Val*, *PCLKSEL1_Val*). This registers are used to divide the core clock (CCLK). In the current project configuration the PCLK is set to CCLK/4.

Additionally the *SystemInit* routine sets up the Phased Locked Loop (PLL) and turns on various peripherals. Via the Power Control for Peripherals register (PCONP) it is possible

to turn on or off all available peripherals. This feature enables the developer to save energy if required.

The second routine which is provided in this file helps the developer to check on which frequency the core is operating. This routine is called *SystemCoreClockUpdate*. The value of CCLK is stored in the variable *SystemCoreClock*.

The file lpc17xx_nvic.c

This file provides the necessary routines to configure the NVIC, to configure the System Control Block (SCB) and to set the vector table offset value. According to these three tasks three routines are implemented.

The first routine disables the NVIC and is called <u>NVIC_DeInit</u>. This function disables the 32 interrupt sources of the CM3, clears all pending interrupts and clears all interrupt priorities.

The second routine disables the SCB and is called *NVIC_SCBDeInit*. The following SCB NVIC peripheral registers are de-initialized:

- Interrupt Control State register
- Interrupt Vector Table Offset register
- Application Interrupt/Reset Control register
- System Control register
- Configuration Control register
- System Handlers Priority Registers
- System Handler Control and State Register
- Configurable Fault Status Register
- Hard Fault Status Register
- Debug Fault Status Register

The third routine sets the vector table offset and is called <u>NVIC_SetVTOR</u>. The CM3 provides a register where the offset value is stored. Listing 10 shows the corresponding code snippet.

```
void NVIC_SetVTOR(uint32_t offset)
{
    SCB->VTOR = offset;
}
```

Listing 10: Vector table offset value register (code snippet)

The mentioned routines are called within the *NVICInit* function explained in e).

The file NVICInit.c

This file provides one routine called *NVICInit* which calls the routines mentioned in d). Additionally this file declares all the necessary interrupt handlers which are called if an interrupt of the corresponding sources occurs.

8.3.2 CMARM subfolder description

The CMARM subfolder provides routines to delete the USB message buffers, to write to or read from the USB interface and to parse the *nop* counts, which are used to implement busy-waiting mechanism for the JTAG clock, for the JTAG functions. Additionally the already declared interrupt handler is implemented and calls another routine located in the USB subfolder.

The *abBulkInBuf[]*, declared in *cmarm_libraries.h*, stores the information of the outgoing bulk transfer and the *abBulkOutBuf[]* stores the information of the incoming bulk transfers.

As mentioned the *cmarm_libraries.c* file provides the routines to handle the USB transfers respectively fill the corresponding buffers, delete the buffers and parse the chosen JTAG frequency to *nop* counts.

If the USB peripheral raises an interrupt the already declared <u>USB_IRQHandler</u> is called. This interrupt service routine calls a function which determines which USB action has to be performed. This routine is located in the USB library placed in the USB subfolder. According to the bulk transfer direction two routines are required. The <u>BulkIn</u> function handles the outgoing bulk data and calls a USB library function, if there is any data to be transmitted. Listing 11 shows the corresponding code snippet.

```
void BulkIn(U8 bEP, U8 bEPStatus)
{
    if(BulkInSize > 0)
    {
        USBHwEPWrite(bEP, abBulkInBuf, BulkInSize);
        deleteBulkInBuf();
    }
}
```

Listing 11: BulkIn routine (code snippet)

The second routine which handles the incoming bulk transfer data is called *BulkOut*. This routine also calls a USB library function and extracts the payload length out of the first two bytes of the transmitted data. Listing 12 shows the corresponding code snippet.

void BulkOut(U8 bEP, U8 bEPStatus)
{
int i;
disable_USB_interrupts();
<pre>for(i=0;i<=CMARMJTAG_BUFFER_SIZE-1;i++)</pre>
{
<pre>abBulkOutBuf[i] = 0;</pre>
}
USBHwEPRead(bEP, abBulkOutBuf, sizeof(abBulkOutBuf));
BulkOutSize = abBulkOutBuf[0]<<8 abBulkOutBuf[1];
BulkOutSize = BulkOutSize - 1;
}

Listing 12: BulkOut routine (code snippet)

To guarantee that the read process is not interrupted it is necessary to disable the USB interrupts. After disabling the interrupts it is necessary to delete the buffer to be sure that only the newest data is provided after reading from the USB device. As explained in chapter 8.2 (figure 12) the first two bytes are illustrating the payload length. The *BulkOutSize* contains the payload length and is used in the main application as parameter for the JTAG library functions. The transmitted payload size is stored with the *sizeof* function which implies that decimal 1 has to be subtracted from the read payload length.

The last routine which is provided by this file is the <u>nop_parser</u>. This function returns a value which is used in the JTAG library to implement busy waiting sequences between the toggle cycles of the JTAG clock pin.

8.3.3 JTAG subfolder description

The JTAG subfolder contains the necessary routines to toggle the pins according to the received USB message. Additionally the routines are responsible to read the JTAG data of the target μ C and store it in an USB message which is transmitted to OpenOCD respectively to the host.

The file *jtag_functions.h* contains the declarations for the implemented routines. The routines are responsible to initialize the pins, which are used for the JTAG transmissions, to output the TAP data at different transfer (clock) rates, to set the TRST and the SRST separately and to set the TRST and the SRST simultaneously.

The second header-file, called $jtag_defines.h$, is also necessary for the JTAG port implementation and defines all necessary pins, commands and masks via macros (#defines). Table 8 describes the mapping between the used µC pins, the corresponding JTAG signals and the pins on the pin-headers of the CMARMJTAG prototype.

JTAG signal	JTAG macro	µC port.bit	pin-header/bit
Test Data Input	JTAG_PIN_TDI	P2.0	J 7/52
Test Mode Select	JTAG_PIN_TMS	P2.1	J12 / 16
Test Reset Input	JTAG_PIN_TRST	P2.2	J12 / 17
Soft Reset Input ¹⁸	JTAG_PIN_SRST	P2.3	J12 / 18
Test Clock Input	JTAG_PIN_TCK	P2.4	J 6/13
Test Data Output	JTAG_PIN_TDO	P2.5	J 6/12

Table 8: JTAG signal / Port.Bit / Pin-Header-Bit mapping

The implementation of the routines is done in *jtag_functions.c*. To optimize the execution speed and the size of the application the compiler optimization for the implemented routines is enabled.

CMARMJTAG firmware optimization

To be able to achieve the maximum JTAG speed of 2 MHz four methods for TAP implementation are possible.

- Bitbang
 - The TAP sequences are implemented via general purpose I/O pins. The clock is generated via busy-waiting statements. This means that the JTAG clock pin is set, than the CPU waits - executes nop statements - and then the CPU resets the clock pin.
 - o Advantages:
 - easy to implement
 - The maximum achievable JTAG clock frequency can't be reached.
 - o Disadvantages:
 - wasting CPU time
 - a deterministic timing can't be guaranteed

Bitbang Optimized

- This method is a similar implementation of the Bitbang method, but the compiler optimization options are enabled.
- Advantages:
 - easy to implement
 - The maximum achievable JTAG clock frequency after reset can be implemented

¹⁸ is not a JTAG signal but required for the JTAG transmission on ARM microcontrollers

- smaller code size and decreased execution time
- o Disadvantage:
 - wasting CPU time

Interrupt driven

- The TAP sequences are also implemented via general purpose I/O pins. But the clock signal (TCK) is generated via timer interrupts where the dedicated clock pins are set and reset.
- o Advantage:
 - CPU time is not wasted
 - deterministic timing is guaranteed
- o Disadvantage
 - The maximum achievable JTAG clock frequency can't be reached. It takes to much machine commands to enter the ISR, process the ISR and to exit the ISR.

• Interrupt driven Optimized

- This method is a similar implementation of the Interrupt driven method, but the compiler optimization options are enabled.
- Advantages & Disadvantages are the same as at the Interrupt driven method.

The four mentioned methods where evaluated during the design process of the CMARMJTAG. Finally for the implementation of the prototype the method Bitbang Optimized is used. Currently in *jtag_functions.c* the compiler optimization option -02 [GCC11] is enabled. Listing 13 shows the corresponding code snippet.

```
#pragma GCC push_options
#pragma GCC optimize ("02")
.....
#pragma GCC pop_options
```

Listing 13: Compiler optimization level (code snippet)

The routine <u>jtag_init</u> initializes the corresponding port and bits for the JTAG port and sets the reset pins high to a passive state.

The $jtag_tap_output$ routines are responsible to send the received USB message to the JTAG TAP of the target μ C. To be able to adjust the JTAG clock different routines are implemented.

TAP output routines:

- jtag_tap_output_max_speed
 - JTAG clock = 2MHz
- jtag_tap_output_with_delay_slow
 - JTAG clock = 100kHz 1MHz
- jtag_tap_output_with_delay_xMx
 - \circ e.g. jtag_tap_output_with_delay_1M1 → JTAG clock is 1.1MHz
 - JTAG clock = 1.1MHz 1.9MHz

As described the JTAG clock can range from 100kHz to 2.0MHz. The granularity is 100kHz. Figure 16 gives an overview of the internal structure of these routines.

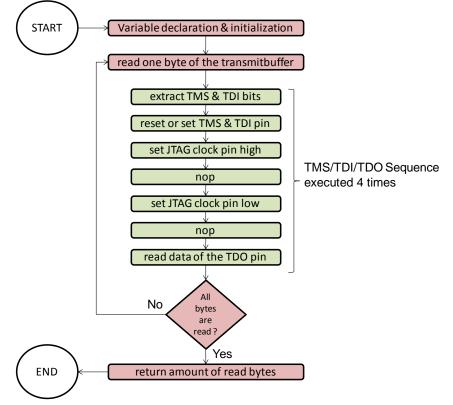


Figure 16: Execution flow of a JTAG TAP Output routine

At the beginning of the routine all necessary variables are declared and initialized. As execution steps forward four TMS/TDI/TDO sequences are executed within an endless loop. This endless loop contains an exit condition which checks whether all bytes are read out of the transmit-buffer. The transmit-buffer contains the bytes of the payload of the received USB message. If all bytes are read the routine returns the amount of bytes

received of the JTAG TAP of the target μ C. One TMS/TDI/TDO sequence extracts the corresponding TMS and TDI bits, resets or sets the TMS and TDI pin, toggles the JTAG clock pin with the desired clock rate and reads the data on the TDO pin, sent by the JTAG TAP of the target μ C. This sequence is executed four times because one byte of the transmit-buffer contains four different TMS/TDI pairs.

The difference between the *jtag_tap_output* routines is that the JTAG clock togglesequence within one TMS/TDI/TDO sequence can be different. In the routine *jtag_tap_output_max_speed* the busy wait mechanism is implemented via *nop* instructions. In the routine *jtag_tap_output_with_delay_slow* this sequence is implemented via a while-loop which executes *nop* instructions till a count variable reaches 0. The value of this count variable is the return value of the *nop_parser* routine explained in chapter 10.3.2. Listing 14 shows the corresponding code snippet.

whi	le(nop_cnt1)
{	
	asmvolatile("nop");
	nop_cnt1;
	if(nop_cnt1==0)
	{
	break;
	}
}	

Listing 14: Busy wait sequence in a *jtag_tap_output* routine (code snippet)

The *jtag_tap_output_with_delay_slow* routine implements the JTAG clocks ranging from 100kHz to 1MHz. The routines *jtag_tap_output_with_delay_xMx* are responsible to implement the JTAG clocks ranging from 1.1MHz to 1.9MHz. These routines realize the clock via a busy-wait mechanism based on unrolled *nop* instructions. The currently achievable maximum clock rate is 2.0MHz. The routine *jtag_tap_output_max_speed* provides this clock rate also based on the busy-wait mechanism used in the *jtag_tap_output_with_delay_xMx*.

The *jtag_functions.c* file not only provides the TAP output routines, it also provides routines to read the input (read TDO pin) implemented in *jtag_read_input*, to set the TRST and the SRST pin separately implemented in *jtag_set_trst* and *jtag_set_srst* and to set the TRST & SRST pins simultaneously implemented in *jtag_set_trst_srst*. The routines in this folder are called from the main application which is described in chapter 8.3.7.

8.3.4 SPI subfolder description

This subfolder contains one header-file and one c-file which are dedicated to implement the JTAG TAP via Serial Peripheral Interface (SPI). Currently the JTAG TAP is implemented via independent μ C-pins. Chapter 11 describes the advantages and disadvantages of this implementation method.

8.3.5 TIMER0 subfolder description

This subfolder contains routines to initialize, start and stop a timer. The timer unit of the CM3 can be used to precisely determine the clock of the JTAG. During the performance test phase, described in chapter 10, this implementation method showed that it decreases the achievable clock rate.

8.3.6 USB subfolder description

The USB subfolder contains all the necessary routines to enable the USB interrupts, to configure the USB peripheral of the CM3, to configure the endpoints according to the given USB descriptor and to transmit and receive an USB message. This project specific USB stack is based on the LPC USB stack [10] provided by NXP. Five source files are located in *USB/src* to provide the routines for these purposes:

- a) intenable.c
- b) usbcontrol.c
- c) usbhw_lpc.c
- d) usbinit.c
- e) usbstdreq.c

The file intenable.c

This file provides routines to enable and disable the USB interrupts. In the main application it should be possible to access LPC/CM3 specific via library routines. Therefore stub-routines are implemented. Two of these routines are intend to enable and disable the USB interrupts. These routines are called *enable_USB_interrupts* and *disable_USB_interrupts*.

The file usbcontrol.c

This file provides routines to handle control transfers. These control transfer handlers are normally installed on endpoint 0. Four different types of control transfers are supported:

- Standard
- Class
- Vendor
- Reserved

It is possible to install a callback for each of these control transfers with *USBRegisterRequestHandler* routine located and explained in c). The default endpoint addresses 0x00 and 0x80 are used to handle the control transfers. These two endpoint 0 configurations are registered within the *USBInit* routine which is described in d).

The file usbhw_lpc.c

This file illustrates the USB hardware layer. This means that LPC/CM3 specific registers are accessed. This file provides routines to configure and enable an endpoint, to register an endpoint event callback, to register an device status callback, to register a frame callback, to set the USB address, to connect or disconnect from the USB bus, to get the status from a specific endpoint, to write to the endpoint buffer, to read from the endpoint buffer and to initialize the USB hardware. Additionally this file provides the routine which is called within the USB interrupt request handler which was described in chapter 8.3.2.

The routines provided in this file, registers the **BulkIn** & **BulkOut** handler if an endpoint interrupt occurs. Figure 17 describes how an USB interrupt is processed.

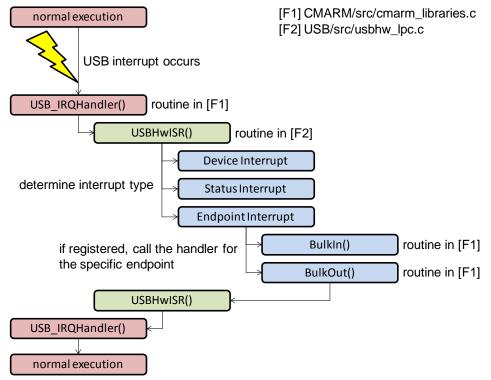


Figure 17: Execution flow if an USB interrupt occurs

During the normal program execution it is possible that an interrupt is raised by the USB peripheral. If such an USB interrupt occurs the already declared USB interrupt handler is called. The USB the file interrupt handler is provided by CMARM/src/cmarm_libraries.c. Within this routine the function USBHwISR is called. This routine determines, based on if-conditions, which type of interrupt occurred. In the initialize phase of the program, processed by the main application described in chapter 8.3.7, two endpoints, one in-endpoint and one out-endpoint, are registered. A handler for each endpoint is also registered in the main application. The USBHWISR determines which interrupt type occurred and calls the corresponding, already registered, handler. This routine is provided by the file <u>usbhw_lpc.c</u>. Table 9 shows the endpoint address to endpoint handler mapping which is currently used.

Endpoint name	Endpoint address	Endpoint handler	Description
BULK_OUT_EP	0x05	BulkOut	Handles the outgoing bulk
			transfers
BULK_IN_EP	0x82	BulkIn	Handles the incoming bulk
			transfers

Table 9: Endpoint address to endpoint handler mapping

The implementation of the *BulkIn* and *BulkOut* handler is shown in Listing 11 & 12 in chapter 8.3.2. After the handler is processed the application continues with normal program execution.

The file usbinit.c

This file provides a routine which uses the USB hardware layer routines described in the previous chapter. The *USBInit* function initializes the USB hardware, installs a reset handler for the USB peripheral, registers and configures an endpoint for the control transfers and registers a handler for USB standard requests.

The file usbstdreq.c

This file provides routines to handle USB standard requests and to configure the USB peripheral according to the given USB descriptor specified in *cmarm_definitions.h*.

8.3.7 Main Application

The main-application updates the core clock of the CM3, initializes the USB peripheral and registers and configures the endpoints for the bulk transfers. Figure 18 shows how the main-application is executed.

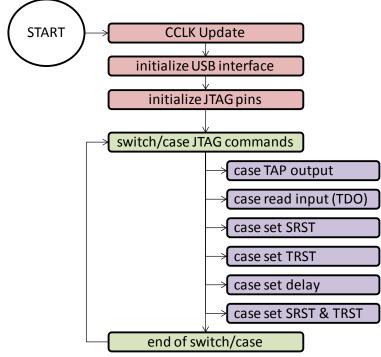


Figure 18: main-application execution flow

After the execution of the commands located in the startup-code the main routine is called. At the beginning of the main application the core clock is updated. This enables the developer to check whether the configured core clock is correct or not. After this update routine, the required routines - described in the previous chapters - are called to initialize and configure the USB peripheral. Additionally the interrupt line for the USB is enabled. If the USB is initialized and configured successfully, the JTAG pins described in chapter 8.3.3 are initialized. Within the endless loop, if a USB message was received, a switch/case routine determines which JTAG command has to be executed. Seven possible JTAG commands are available.

The case *TAP output* transmits and receives the data to and from the target μ C. According to the configured JTAG delay (JTAG clock frequency) the corresponding routine is called.

The case *TAP output EMU* is implemented but not used in the current used project configuration.

In the case *read input (TDO)* the current status of the TDO pin and the EMU pin is returned. This case can be used for further development.

The case *set SRST* pulls the SRST pin of the CMARMJTAG high. This means that a software reset is enabled.

In the case *set TRST* the JTAG state machine of the target debug module is enabled. These two routines are necessary to set the SRST and TRST independent of each other. The last case *set SRST & TRST* is implemented to be able to simultaneously set the according pins.

The case set delay stores the required JTAG clock frequency in Hertz [Hz] in a variable. This routine is required to guarantee that the JTAG module of the target μ C is clocked with the correct clock frequency. If the clock frequency is smaller than 1kHz, the *nop_parser* is called to provide the *nop* count for further communication. As described the clock frequency can be set via the configuration script of OpenOCD or, if the host is connected to the target μ C via telnet, it can be set with the command *jtag_khz* xxxx.

At the end of every case the USB buffer is deleted, to guarantee that only the newest USB message payload is processed within the switch/case statement.

9 Test environment

This chapter describes the test environment (TE). The TE contains the components described in figure 10. Additionally an Agilent MSO6104A oscilloscope is used to monitor the JTAG communication between the CMARMJTAG and the target μ C. On the host workstation Eclipse Galileo is installed. This IDE is used as graphical user interface to edit c-code. In the IDE two makefile projects implementing OpenOCD compiled for the CMARMJTAG and FTDI-based devices are included. The IDE is used to debug OpenOCD. Additionally a virtual machine is running on the host workstation to be able to develop and debug the firmware for the CMARMJTAG. This development concept (Eclipse IDE with OpenOCD as a makefile-project and virtual machine with Eclipse IDE for ARM firmware cross-development) is necessary to simultaneously implement the required routines. Figure 19 shows the assembled test environment and its configuration.

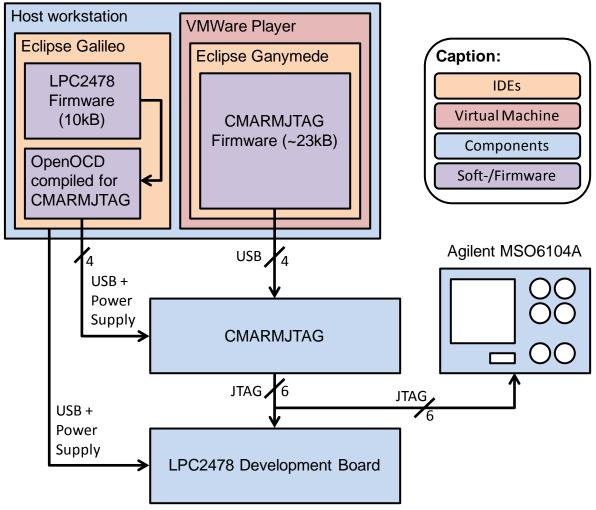


Figure 19: Test environment

The host workstation provides a locally installed Eclipse Galileo with a small test project with a size of 10kBytes. This project is compiled with the compiler suite CodeSourcery G++ Lite¹⁹.

The firmware initializes the LPC2478, sets up the PLL and all other system components and implements a blinking LED on the development board. The project also contains a simple OpenOCD configuration script which opens different ports for the GDB, for telnet and TCL, configures the JTAG TAP and adjusts the JTAG clock frequency.

Also a pre-configured makefile project is included in the IDE. OpenOCD can be preconfigured via the command line. If the adjustments described in chapter 10.1 are successfully completed it is possible to configure OpenOCD for the CMARMJTAG. The following command has to be executed to configure OpenOCD.

./configure --enable-cmarmjtag --enable-libftdi

First the interface which is used to connect to the target hardware is enabled and the building support for libit compatible devices is also enabled. If OpenOCD is preconfigured it can be built by executing *make*. It is also possible to create a makefile project in Eclipse Galileo and execute the make process automatically.

The VMWare Player provides a virtual machine based on Debian 5 Lenny. In the virtual machine Eclipse Ganymede is used to develop the firmware for the CMARMJTAG. Currently the firmware has a size of approximately 23kBytes.

This firmware is flashed via USB and a FTDI-based debugger on the CMARMJTAG prototype. OpenOCD connects itself via the provided USB peripheral of the CMARMJTAG to the LPC2478 Development Board. As described the JTAG pins of the LPC2478 are connected to the CMARMJTAG and simultaneously monitored via the logic analyzer of the oscilloscope. The Development Board is USB powered and connected to the host workstation.

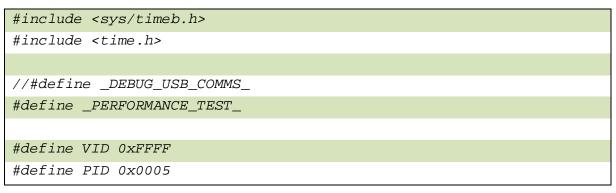
¹⁹ http://www.codesourcery.com/

10Performance analyses

The project configuration shown in figure 19 builds the basis for the performance analyses. This chapter describes how the performance test where performed and how the output is interpreted.

10.1 Performance test configuration

To be able to measure the single step time, the download time and the download speed it is necessary to display timestamps on the console to verify the elapsed time. It is possible to enable the timestamps via a macro in the CMARMJTAG interface driver of OpenOCD. Listing 15 shows the mentioned c-code lines.



Listing 15: CMARMJTAG interface driver "Performance Test" (code snippet)

The <u>PERFORMANCE_TEST</u> macro is dedicated to enable the timestamps functionality. During the download process timestamps are displayed. This enables the developer to calculate the time between the beginning of the download process and end. With this ability it is also possible to calculate the elapsed time between the beginning of the single step and the end of the single step. These two parameters are used to test the debugger (CMARMJTAG). Two different types of tests were executed. One test scenario was that the compiled LPC2478 firmware was loaded via the GNU Debugger (GDB) to the Development Board. In the second test scenario the telnet connection, provided by OpenOCD, was used to erase the flash memory and to write the pre-compiled image to the flash memory of the LPC2478. The results of these two test scenarios are described in the chapter 10.2.

To utilize the performance test results, described in chapter 10.3, it is necessary to calculate the download speed. OpenOCD provides a routine which calculates the download speed automatically. As mentioned the second test scenario uses a telnet connection to connect to OpenOCD respectively to the target μ C. Within this test scenario the download speed is calculated. To be able to understand the output of the performance test it is necessary to know how OpenOCD calculates the download speed. Listing 16 shows the corresponding code snippet of the OpenOCD source tree.

```
float duration_kbps(struct duration *duration, size_t count)
{
    return count / (1024.0 * duration_elapsed(duration));
}
```

Listing 16: OpenOCD download speed calculation (code snippet)

The variable *count* is the downloaded amount of bytes and with the routine *duration_elapsed(duration)* the elapsed download time is measured. Due to this calculation method the calculated download speed increases with the downloaded amount of bytes.

10.2 Performance test results

The previous chapter described which options have to be configured to enable the performance test and what types of test scenarios were applied. This chapter describes the results of these test scenarios. The CMARMJTAG firmware was not optimized. The download process includes different GDB commands. Listing 17 shows the executed commands.

target remote localhost:3333
file "/path/to/the/*.elf-file"
monitor reset
monitor halt
monitor poll
set \$pc=0x0
thbreak main
load

Listing 17: Eclipse Debug configurations for LPC2478 (GDB commands)

The first command in Listing 17 opens a connection to the specified GDB port. The second command loads the symbols of the *.elf file which is loaded to the LPC2478. After loading the symbols it is necessary to perform a reset sequence and to halt the core. The command *monitor poll* is not necessary, but helps the developer to verify the state of the core. After polling the core state the program counter (pc) is set to 0x0 and a hardware assisted breakpoint is set at the beginning of the main routine with *thbreak main*. The hardware assisted breakpoint is only enabled for one stop. The breakpoint is automatically deleted after the first time the program stops at this breakpoint. This breakpoint requires hardware support and some target hardware may not have this support.

GDB breakpoint commands on embedded targets

The GDB offers four different commands to insert a breakpoint into an application. This digression describes the following commands and how they are implemented on embedded targets:

- break function
- tbreak function
- hbreak function
- thbreak function

The break *function* command inserts a breakpoint at the entry point of a given function (routine). The tbreak *function* command inserts a breakpoint at the entry point of a given function enabled for only one stop. The t in this command stands for temporary. If the program stops at this breakpoint it is automatically deleted. The hbreak *function* command inserts a hardware-assisted breakpoint at the entry point of the given function. The hardware-assisted breakpoint is explained at the *thbreak main* command explanation. The thbreak *function* command inserts a temporary hardware-assisted breakpoint at the given function.

On embedded targets there is no difference between hardware-assisted breakpoints (hbreak *function*) and breakpoints (break *function*). There is only a difference between hardware breakpoints (hardware-assisted breakpoints) and software breakpoints.

The watchpoint unit of the ARM7TDMI-S offers the insertion of two hardware breakpoints. If a breakpoint is inserted with the corresponding GDB command the address of this breakpoint is stored in the watchpoint unit. During program execution the watchpoint unit compares the current value of the program counter and the breakpoint address. If these two values are equal, an exception is thrown and the GDB and the program execution stops.

To insert software breakpoints no watchpoint unit is required. This means that the GDB modifies the code at the positions of the software breakpoint. The problem is that adding software breakpoints is only possible if the flash banks are not write protected, which implies that software breakpoints are only available, if the application is debugged in the RAM memory of the microcontroller.

At the ARM7TDMI-S microcontroller, as mentioned, two breakpoints are possible to insert. This implies that if two breakpoints already existing in the current running application, single stepping is not possible because this feature also requires breakpoints. Therefore, the command *thbreak main* is a good alternative enable the developer to set two breakpoints in the current running application because debugging with only two breakpoints is very tough.

After this digression about GDB breakpoints the last command which is executed is the *load* command. This command completes the download process.

At the first performance test, with non-optimized code, it took **3.42 seconds** to execute the download process via the GDB. Additionally the time between the beginning of a single step and the completion of the single step is measured. It takes **118ms** to step over (single step) the following instruction FIO2SET = (1 << 10);

The second performance test, with partial optimized code, took **3.32 seconds** to execute the download process via the GDB. The single step took **84ms** to complete it.

In the second test scenario the host workstation opens a telnet connection, erases the memory and writes the pre-compiled image to the on-chip memory (Listing 18). Two performance test of this scenario where executed.

The first performance test was executed with the following commands.

telnet localhost 4444
reset halt
poll
flash erase_sector 0 0 26
<pre>flash write_image "/path/to/the/*.elf-file" 0x0 elf</pre>

Listing 18: OpenOCD commands via telnet (OpenOCD commands)

Two parameters can be extracted of this test. The first parameter is the elapsed time the erase process takes. The second parameter illustrates the elapsed time of the write process.

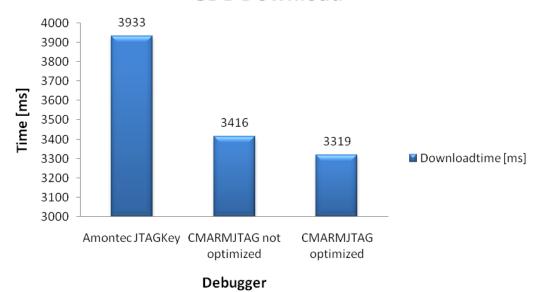
At the first performance test, with non-optimized code, it took **0.18 seconds** to erase the memory and it took **0.33 seconds** to write the *.elf file to the memory of the LPC2478. The download speed [KiB/s] at this performance test is **4.8 KiB/s**.

The second performance test, with partial optimized code, took **0.17 seconds** to erase the memory and it took **0.3 seconds** to write the *.elf file to the memory of the LPC2478. The download speed [KiB/s] at this performance test is **5.3 KiB/s**.

To be able to utilize the output of these performance tests it is necessary to compare the results with another OpenOCD compatible debugger. The following chapter compares the CMARMJTAG with an FTDI-based debugger of Amontec called Amontec JTAGKey.

10.3 Performance test utilization

This chapter compares the performance test output of the previous chapter with the performance test output of the Amontec JTAGKey debugger. The JTAG clock in all the following test comparisons is configured to 2000 kHz and the program size is 10 Kbytes. Figure 20 shows the elapsed time of the GDB download process described in the previous chapter.



GDB Download

Figure 20: GDB download performance test

The download process based on the Amontec JTAGKey takes **3933 ms** to be completed. The same test with the non-optimized firmware on the CMARMJTAG takes **3416 ms** and after the partial code optimization it takes **3319 ms** to download a compiled firmware to the LPC2478. This test shows that the download process with the partial optimized firmware on the CMARMJTAG can be completed faster than the same sequence based on the Amontec JTAGKey. Compared to the Amontec JTAGKey the non-optimized version of the CMARMJTAG is **13.1%** faster and the optimized version of the debugger is **15.6%** faster.

Figure 21 shows the single step time to write a value to a 32-bit register. There is also a comparison between the Amontec JTAGKey, the non-optimized firmware on the CMARMJTAG and the optimized firmware on the CMARMJTAG.

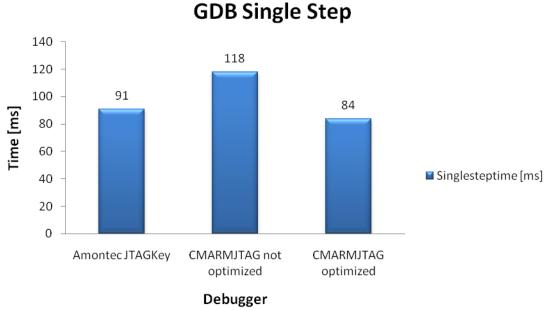
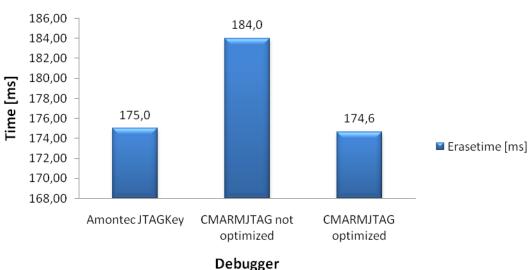


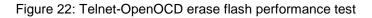
Figure 21: GDB single step performance test

It takes **91 ms** to step over a single instruction in C, if the Amontec JTAGKey is used. The CMARMJTAG, with the non-optimized firmware, requires **118 ms** to step over a single C instruction. The CMARMJTAG with the optimized firmware requires only **84 ms** to step over a single instruction. This comparison shows that the CMARMJTAG with the optimized firmware is faster than the Amontec JTAGKey, if a single step in C is performed. In this example the non-optimzed version of the CMARMJTAG is **29.7%** slower and the partial optimzed version of the debugger is **7.7%** faster than the Amontec JTAGKey. Figure 20 and 21 are illustrating the performance test output of the first test scenario described in the previous chapter.

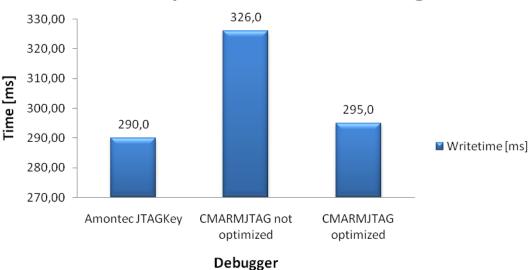
Figure 22, 23 and 24 are illustrating the perfromance test output of the second test scenario which was described in the previous chapter. Figure 22 shows the elpased time of eraseing the flash memory (512 KiB) of the LPC2478 using a telnet connection and OpenOCD based on various debuggers.



Telnet-OpenOCD Flash Erase



The Amontec JTAGKey requires **175 ms** to erase the flash memory of the LPC2478. The CMARMJTAG with the non-optimized firmware requires **184 ms** and the optimized version requires **174.6 ms** to erase the flash memory. This means that the non-optimized version is **5.14%** slower and the optimized version is **0.21%** faster than the Amontec JTAGKey. Figure 23 shows the time it takes to download an image file via telnet and OpenOCD based on three different debugger versions. The elapsed time is automatically measured by OpenOCD.



Telnet-OpenOCD Flash Write Image

Figure 23: Telnet-OpenOCD write image to flash performance test

The download process via telnet and OpenOCD takes **290 ms** via the Amontec JTAGKey, the non-optimized version of the CMARMJTAG requires **326 ms** to download the image file and the optimzed version of the debugger takes **295 ms** for the download process. This means that the non-optimzed version of the CMARMJTAG is **12.42%** slower and the optimized version of the debugger is **1.73%** slower than the Amontec JTAGKey. Figure 24 illustrates the last part of the second performance test scenario. OpenOCD automatically prints the download speed in kB/s out on the console, if a telnet connection is used to load the image to a target μ C.

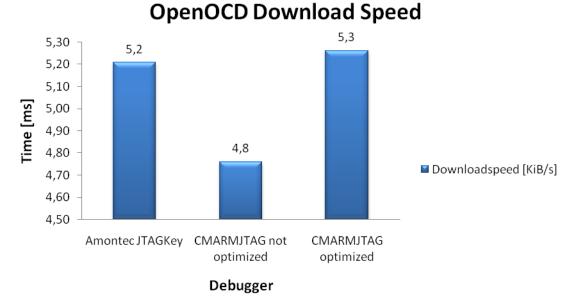


Figure 24: OpenOCD download speed [KiB/s]

The download speed of the Amontec JTAGKey is **5.2 KiB/s**. The speed of the nonoptimized version of the CMARMJTAG is **4.8 KiB/s** and the download speed of the optimized version of the debugger is **5.3 KiB/s**. This means that the developed debugger is **8.6%** slower in the non-optimized version and **1.01%** faster, if the optimized version is used, compared to the Amontec JTAGKey.

	GDB Download [ms]	GDB Single Step [ms]	Flash Erase [ms]	Flash Write [ms]	Download Speed [KiB/s]
JTAGKey	3933,0	91,0	175,0	290,0	5,2
CMARMJTAG *	3416,0	118,0	184,0	326,0	4,8
CMARMJTAG **	3319,0	84,0	174,6	295,0	5,3

Table 1	0: Debuager	comparison
Tuble I	0. Debugger	oompanoon

Table 10 summarizes the results of the performance tests. The red background cell colour illustrates results which are worse compared to the JTAGKey and the green background cell colour illustrates results which are better than the JTAGKey.

The optimized version of the CMARMJTAG shows better results in almost all categories and is a good alternative to the commercial available Amontec JTAGKey.

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11 Conclusion & Add-Ons

 μ C-based debuggers have a wide spread application area and are used very often. These debuggers are offering many features which are handy to design μ C firmware and to verify them. The open source and free available development tools, used in this project, are very comfortable and easy to fit into a prototyping process in education. This chapter summarizes the important points mentioned in this thesis and should highlight ideas for further development of the CMARMJTAG.

This thesis described the development process of a µC-based debugger. This thesis also describes selected topics of the interfaces (JTAG & USB) used in this project. A state-ofthe-art μ C, ARM CM3, is used to meet the requirements of the debugger. OpenOCD, an open source project, is used to connect to the target µC (JTAG compliant hardware). OpenOCD already supports a high amount of interfaces respectively debuggers. The integration of such a new interface into OpenOCD and the development of the according driver are also explained in this thesis. To be able to connect to the host workstation via USB and to communicate with the target μ C via JTAG it is necessary to implement proper drivers and integrate these drivers into a firmware framework of the CM3. The firmware structure and the usage of the drivers as well as the framework are explained in this thesis. The primary goal was to achieve the same performance and features like a commercial available debugger. The performance tests results are compared to the Amontec JTAGKey. The test scenarios and the execution of these performance tests are documented in this thesis. Finally it was necessary to utilize the performance output. The corresponding figures are described and documented in chapter 10. The performance test results showed that it is possible to achieve almost the same performance as a commercial available debugger.

Finally the CMARMJTAG is a device which can be used on the one hand as a tiny μ C platform for educational purposes and on the other hand as a debugger for more sophisticated μ C platforms. The used development tools are open-source or free available. Currently at the Institute of Embedded Systems²⁰ a R&D Project called "Embedded Platforms"²¹ sponsored by the MA27 under grant 10-07 focuses on the development of a μ C platform which can be used in courses dedicated to embedded systems engineering. The CMARMJTAG and its development environment will be the key components for this μ C platform.

²⁰ http://embsys.technikum-wien.at/index.php

²¹ http://embsys.technikum-wien.at/projects/EmbPlat/index.php

Further improvements

The CMARMJTAG offers many opportunities for further development. The core features are already implemented but there are some improvements which could be developed and useful in embedded software development and education.

Virtual COM port

To be able to use *printf()* "debugging" or to be able to use the same interface (USB) for debugging and serial data transmission an implementation of a virtual COM port can be an improvement for the debugger. The RS232 interface is a simple interface and there are many applications which are possible to implement based on the RS232 interface which means that this additional feature makes the CMARMJTAG attractive for education.

JTAG via SPI interface

After reset the ARM CPU operates at a core clock frequency of 4 MHz which is provided by the internal oscillator. To be able to communicate with the debug module of the CPU it is necessary to configure the JTAG clock to 2 MHz. This restriction limits the maximum achievable download speed. But OpenOCD offers command line options to configure core and peripheral registers before the program is loaded to the target μ C. This means that it is possible to configure the core to use the external oscillator and to configure the PLL before the program is loaded to the μ C. The maximum achievable clock frequency using software bitbang is 2 MHz. But if the SPI interface of the CMARMJTAG is used to download the firmware it is possible to achieve JTAG speeds of 10 MHz. Due to this fact using SPI as a TAP enables the developer to download and debug the firmware much faster than for example the Amontec JTAGKey Tiny.

eStick v2

The last improvement is to develop a successor to the eStick²². The eStick is a small μ C-Platform which consists of a AT90USB162 μ C from Atmel. This platform is currently used in basic courses dedicated to embedded systems engineering. The advantages of such a successor are:

- a powerful µC platform is used
- debugging is available
- the eStick v2 can be used to debug other target μ Cs

To overcome the need of on-board debugger respectively programmer to program the eStick v2 it is necessary to implement a self-flashing feature. This means that the eStick v2 registers itself as a mass storage on the host workstation and the pre-compiled machine code can be copied to the mass storage. If a power cycle is performed the eStick v2 loads the file into its internal memory and starts executing the program.

²² http://embsys.technikum-wien.at/staff/horauer/estick/estick.php

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List of Abbreviations

μC	Microcontroller
00h	0 hexadecimal
ACK	Acknowledge
CCLK	Core Clock
CM3	Cortex-M3
DAP	Debug Access Port
DLH	Data Length High Byte
DLL	Data Length Low Byte
DP	Debug Port
EEPROM	Electrically Erasable Programmable Read-Only Memory
EMU	Emulator
EP	Endpoint
ETM	Embedded Trace Macrocell
FSM	Finite State Machine
GDB	GNU Debugger
GNU	GNU Is Not Unix
ICC	Integrated Circuit Card
ID	Identification
IDE	Integrated Development Environment
IRQ	Interrupt
JTAG	Joint Test Action Group
JTC	JTAG Command
LTS	Long Term Stable
MPU	Memory Protection Unit
NAK	Not Acknowledge
NVIC	Nested Vectored Interrupt Controller
OpenOCD	Open On-Chip Debugger
OS	Operating System
PC	Personal Computer
PCLK	Peripheral Clock
PCONP	Power Control for Peripheral
PID	Product Identification
PLL	Phase Locked Loop
RISC	Reduced Instruction Set
RUNBIST	Run Built-In Self Test
SCB	System Control Block
SCS	System Control and Status
SPI	Serial Peripheral Interface
SWD	Serial Wire Debug

SWIM	Single Wire Interface Module
TAP	Test Access Port
ТСК	Test Clock
TDI	Test Data Input
TDO	Test Data Output
TE	Test Environment
TEP	Target Embedded Platform
TMS	Test Mode Reset
TPIU	Trace Port Interface Unit
TRST	Test Reset
TTL	Transistor-Transistor Logic
USB	Universal Serial Bus
VIC	Vectored Interrupt Controller
VID	Vendor Identification

Appendix

The following documents, data sheets, user manuals, etc. are stored on the DVD dedicated to this thesis:

- Documents:
 - The master thesis in *.doc and *.pdf
 - The LPC17xx User Manual
 - o The Definitive Guide to ARM Cortex-M3
 - o The diploma thesis "Open On-Chip Debugger"
 - o The OpenOCD User's Guide
 - o The IEEE Std. 1149.1-2001 (R2008) JTAG Specification
- Software
 - o Sample programs for the LPC1768
 - o LPC17xx CMSIS library
 - o OpenOCD 0.4.0
 - o Backups
 - OpenOCD compiled for the CMARMJTAG
 - OpenOCD compiled for FTDI-based debugger
 - CMARMJTAG firmware "ARMJTAGDebugger"
- Performance Test
 - o Results of the performance tests in *.txt files
- Pictures
 - Pictures of the CMARMJTAG JTAG communication startup sequence
 - o All pictures used in this thesis
 - o Screen dumps used in this thesis